

Technical documentation



Support & training



ADC3660 SBASA01B – SEPTEMBER 2020 – REVISED MARCH 2022

# ADC3660 16-Bit, 0.5 to 65-MSPS, Low-Noise, Low Power Dual Channel ADC

# 1 Features

- Dual channel
- 16-bit 65 MSPS ADC (max output rate = 31 Msps)
- Noise floor: -159 dBFS/Hz
- Ultra-low power: 71 mW/ch at 65 MSPS
- 16-Bit, no missing codes
- INL: ±2 LSB; DNL: ±0.2 LSB
- Reference: external or internal
- Input bandwidth: 900 MHz (3 dB)
- Industrial temperature range: –40°C to +105°C
- · On-chip digital down converter
  - Decimation by 2, 4, 8, 16, 32
  - 32-bit NCO
- Serial CMOS interface
- Single 1.8-V supply
- Small footprint: 40-WQFN (5 mm × 5 mm) package
- Spectral performance (f<sub>IN</sub> = 5 MHz):
  - SNR: 81.9 dBFS
  - SFDR: 88 dBc HD2, HD3
  - SFDR: 102 dBFS worst spur

# **2** Applications

- Data acquisition (DAQ)
- Motor diagnostics & monitoring
- Power quality analyzer
- Power quality meter
- Sonar
- Radar
- Defense radio
- Wireless communications
- Lab & field instrumentation
- Spectrometers

# **3 Description**

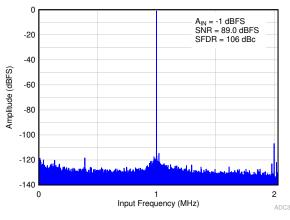
The ADC3660 device is a low-noise, ultra-low power, 16-bit, 65-MSPS dual-channel, high-speed analog-todigital converter (ADCs). Designed for low power consumption, the device delivers a noise spectral density of –159 dBFS/Hz, combined with excellent linearity and dynamic range. The ADC3660 offers excellent dc precision, together with IF sampling support, which make the device an excellent choice for a wide range of applications. The ADC consumes only 71 mW/ch at 65 MSPS, and power consumption scales very well with lower sampling rates. In bypass mode (up to 31 MSPS) the output data is available after 1 or 2 clock cycles.

The ADC3660 uses a serial CMOS (SCMOS) interface to output the data which minimizes the number of digital interconnects. The device supports a two-lane, a one-lane and a half lane option. The serialized CMOS interface supports output rates to 250 Mbps which translates to ~ 15 MSPS (2-wire) to ~ 3.75 MSPS (0.5-wire) output rates after complex decimation. Hence the ADC3660 can be operated in 'oversampling + decimating' mode using the internal decimation filter in order to improve the dynamic range and relax external anti-aliasing filter.

The device comes in a 40-pin WQFN package (5 mm  $\times$  5 mm) and supports the extended industrial temperature range of -40 to +105°C.

PART NUMBER (1)	PACKAGE	BODY SIZE (NOM)
ADC3660	WQFN (40)	5.00 × 5.00 mm

(1) For all available packages, see the package option addendum at the end of the data sheet.



FS = 65 MSPS, F<sub>in</sub> = 1 MHz, 16x Decimation, real



# **Table of Contents**

1 Features	1
2 Applications	
3 Description	
4 Revision History	
5 Pin Configuration and Functions	3
6 Specifications	
6.1 Absolute Maximum Ratings	5
6.2 ESD Ratings	
6.3 Recommended Operating Conditions	
6.4 Thermal Information	
6.5 Electrical Characteristics - Power Consumption	6
6.6 Electrical Characteristics - DC Specifications	7
6.7 Electrical Characteristics - AC Specifications	8
6.8 Timing Requirements	.10
6.9 Typical Characteristics	
7 Parameter Measurement Information	19
8 Detailed Description	.21
8.1 Overview	
8.2 Functional Block Diagram	

8.3 Feature Description	22
8.4 Device Functional Modes	
8.5 Programming	
8.6 Register Maps	
9 Application and Implementation	
9.1 Typical Application	
9.2 Initialization Set Up	
10 Power Supply Recommendations	
11 Layout	70
11.1 Layout Guidelines	
11.2 Layout Example	
12 Device and Documentation Support	
12.1 Support Resources	
12.2 Trademarks	
12.3 Electrostatic Discharge Caution	71
12.4 Glossary	
13 Mechanical, Packaging, and Orderable	
Information	71

# **4 Revision History**

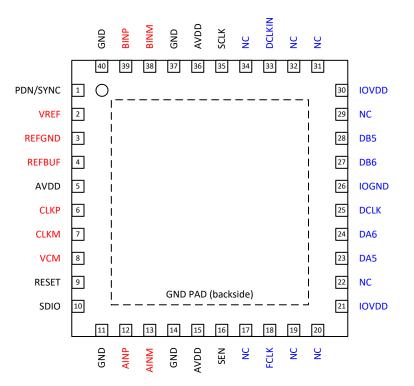
NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

С	Changes from Revision A (October 2020) to Revision B (March 2022) Pa				
•	Changed the output clock jitter unit from ps to ps pk-pk in the Timing Requirements	10			
•	Changed the ADC latency CMOS 2-wire NOM value from 1 to 2 and 1/2-wire NOM value from 2 to 1	10			
•	Changed Figure 8-3	22			
•	Added GND symbol to REFGND pin for all voltage reference option diagrams	27			
•	Added the Output Bit Mapper section.	39			
	Added default power up configuration summary Table 8-11				
	Updated power-up initialization diagram Figure 9-4 with the correct indexing				
_					

С	Changes from Revision * (September 2020) to Revision A (October 2020)		
•	Added Updated characterization data for t <sub>CD</sub> and t <sub>DV</sub>	10	
•	Added condition to resynch during operation to the SYNC section		
•	added wait condition of 200000 clock cycles	67	



# **5** Pin Configuration and Functions



# Figure 5-1. RSB Package, 40-Pin WQFN (Top View)

#### Table 5-1. Pin Descriptions

PIN I/O			Decerimtion			
		"//	Description			
INPUT/REFER	ENCE					
AINP	12	I	Positive analog input, channel A			
AINM	13	I	Negative analog input, channel A			
BINP	39	I	Positive analog input, channel B			
BINM	38	I	Negative analog input, channel B			
VCM	8	0	Common-mode voltage output for the analog inputs, 0.95 V			
VREF	2	I	External voltage reference input, 1.6 V			
REFBUF	4	I	1.2V external voltage reference input for use with internal reference buffer. Internal 100 pull-up resistor to AVDD. This pin is also used to configure default operating conditions			
REFGND	3	I	Reference ground input, 0 V			
CLOCK						
CLKP	6	I	Positive differential sampling clock input for the ADC			
CLKM	7	I	Negative differential sampling clock input for the ADC			
CONFIGURATI	CONFIGURATION					
PDN/SYNC         1         Power down/Synchronization input. This pin can be configured via the SPI interface. Active high. This pin has an internal 21 kΩ pull-down resistor.						



Table 5-1. Pin Descriptions (continued)						
	PIN	I/O	Description			
Name	No.	1/0	Description			
RESET	9	I	Hardware reset. Active high. This pin has an internal 21 k $\Omega$ pull-down resistor.			
SEN	16	I	Serial interface enable. Active low. This pin has an internal 21 k $\Omega$ pull-up resistor to AVDD.			
SCLK	35	I	Serial interface clock input. This pin has an internal 21 k $\Omega$ pull-down resistor.			
SDIO	10	I/O	Serial interface data input and output. This pin has an internal 21 k $\Omega$ pull-down resistor.			
NC	17,19,20,22, 29,31,32,34	-	Do not connect			
DIGITAL IN	TERFACE					
DA6	6 24 O CMOS data output.		CMOS data output.			
DA5	23	0	CMOS data output			
FCLK	18	0	CMOS frame clock output			
DB6	27	0	CMOS data output.			
DB5	28	0	CMOS data output			
DCLKIN	33	I	CMOS bit clock input			
DCLK	25	0	CMOS bit clock output			
POWER SU	IPPLY					
AVDD	5,15,36	I	Analog 1.8V power supply			
GND	11,14,37,40, PowerPad	I	Ground, 0V			
IOVDD	21,30	Ι	1.8V power supply for digital interface			
IOGND	26	I	Ground, 0V for digital interface			



# **6** Specifications

#### 6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>

PARAMETER	TEST CONDITIONS	MIN	MAX	UNIT
Supply voltage range, AVDD, IOVDD		-0.3	2.1	V
Supply voltage rang	ge, GND, IOGND, REFGND	-0.3	0.3	V
Voltage applied to input pins	AINP/M, BINP/M, CLKP/M	-0.3	2.1	
	VREF, REFBUF	-0.3	2.1	V
	PDN/SYNC, RESET, SCLK, SEN, SDIO, DCLKIN	-0.3	2.1	
Junction temperatu	re, T <sub>J</sub>		105	°C
Storage temperature, T <sub>stg</sub>		-65	150	°C

(1) Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

#### 6.2 ESD Ratings

		VALUE	UNIT
	Human body model (HBM), per ANSI/ ESDA/JEDEC JS-001, all pins <sup>(1)</sup>	2500	
V <sub>(ESD)</sub>	Charged device model (CDM), per JEDEC specification JESD22-C101, all pins <sup>(2)</sup>	1000	V

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

### 6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

			MIN	NOM	MAX	UNIT
Supply	voltago rongo	AVDD <sup>(1)</sup>	1.75	1.8	1.85	V
	voltage range	IOVDD <sup>(1)</sup>	1.75	1.8	1.85	V
T <sub>A</sub> Operating free-air temperature		2	-40		105	°C
T <sub>J</sub> Operating junction temperature		e			105 <mark>(2)</mark>	°C

(1) Measured to GND.

(2) Prolonged use above this junction temperature may increase the device failure-in-time (FIT) rate.



#### 6.4 Thermal Information

		ADC3660	
THERMAL METRIC <sup>(1)</sup>		RSB (QFN)	UNIT
		40 Pins	
R <sub>OJA</sub>	Junction-to-ambient thermal resistance	30.7	°C/W
R <sub>OJC(top)</sub>	Junction-to-case (top) thermal resistance	16.4	°C/W
R <sub>ØJB</sub>	Junction-to-board thermal resistance	10.5	°C/W
$\Psi_{JT}$	Junction-to-top characterization parameter	0.2	°C/W
$\Psi_{JB}$	Junction-to-board characterization parameter	10.5	°C/W
R <sub>OJC(bot)</sub>	Junction-to-case (bottom) thermal resistance	2.0	°C/W

(1) For more information about traditional and new thermal metrics, see the *Semiconductor and IC Package Thermal Metrics* application report, SPRA953.

# 6.5 Electrical Characteristics - Power Consumption

Typical values are over the operating free-air temperature range, at  $T_A = 25^{\circ}$ C, full temperature range is  $T_{MIN} = -40^{\circ}$ C to  $T_{MAX} = 105^{\circ}$ C, ADC sampling rate = 65 MSPS, 50% clock duty cycle, AVDD = IOVDD = 1.8 V, external 1.6 V reference, 5 pF output load, and -1-dBFS differential input, unless otherwise noted

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
FS = 65 M	SPS	· · · ·			I	
I <sub>AVDD</sub>	Analog supply current	FS = 65 MSPS, External reference		64	78	mA
IIOVDD	I/O supply current <sup>(1)</sup>	8x real decimation, 2-wire CMOS	15 20			ША
P <sub>DIS</sub>	Power dissipation <sup>(1)</sup>	External reference		142	178	mW
		16x real decimation, 1-wire CMOS		14		mA
		32x real decimation, 1-wire CMOS		12		mA
		32x real decimation, 1/2-wire CMOS		13		mA
		8x complex decimation, 2-wire CMOS		19		mA
I <sub>IOVDD</sub> I/	I/O supply current <sup>(1)</sup>	16x complex decimation, 1-wire CMOS		17		
		32x complex decimation, 1-wire CMOS		15		mA
		32x complex decimation, 1/2-wire CMOS		16		
MISCELL	ANEOUS				1	
	Internal reference, additional analog supply current			3		
AVDD	Internal reference buffer, additional analog supply current	Enabled via SPI		0.3		mA
	Single ended clock input, reduces analog supply current by			0.7		
Power consumption in global pow		Default mask settings, internal reference		5		m\\/
P <sub>DIS</sub>	down mode	Default mask settings, external reference	9		mW	

(1) Measured with a 1 MHz input frequency full-scale sine wave at specified sample rate, with ~ 5 pF loading on each CMOS output pin.



#### 6.6 Electrical Characteristics - DC Specifications

Typical values are over the operating free-air temperature range, at  $T_A = 25^{\circ}$ C, full temperature range is  $T_{MIN} = -40^{\circ}$ C to  $T_{MAX} = 105^{\circ}$ C, ADC sampling rate = 65 MSPS, 50% clock duty cycle, AVDD = IOVDD = 1.8 V, external 1.6 V reference, and -1-dBFS differential input, unless otherwise noted

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
DC ACCUR	ACY					
No missing o	codes		16			bits
PSRR		F <sub>IN</sub> = 1 MHz		50		dB
DNL	Differential nonlinearity	F <sub>IN</sub> = 5 MHz	-0.5	± 0.2	+1	LSB
INL <sup>(1)</sup>	Integral nonlinearity	F <sub>IN</sub> = 5 MHz	-4.5	± 2	+4.5	LSB
V <sub>OS_ERR</sub>	Offset error		-130	2	130	LSB
V <sub>OS_DRIFT</sub>	Offset drift over temperature			-3.5		LSB/ºC
GAIN <sub>ERR</sub>	Gain error	External 1.6V Reference		0		%FSR
GAIN <sub>DRIFT</sub>	Gain drift over temperature	External 1.6V Reference		10.3		ppm/ºC
GAIN <sub>ERR</sub>	Gain error	Internal Reference		2.4		%FSR
GAIN <sub>DRIFT</sub>	Gain drift over temperature	Internal Reference		108.8		ppm/⁰C
Transition N	oise			1.5		LSB
	OG INPUT (AINP/M, BINP/M)	· · · ·	i			
FS	Input full scale	Differential		3.2		Vpp
V <sub>CM</sub>	Input common model voltage		0.9	0.95	1.0	V
R <sub>IN</sub>	Differential input resistance	F <sub>IN</sub> = 100 kHz		8		kΩ
C <sub>IN</sub>	Differential input Capacitance	F <sub>IN</sub> = 100 kHz		7		pF
V <sub>OCM</sub>	Output common mode voltage			0.95		V
BW	Analog Input Bandwidth (-3dB)			900		MHz
INTERNAL	VOLTAGE REFERENCE	I	I			
V <sub>REF</sub>	Internal reference voltage			1.6		V
V <sub>REF</sub> Output	Impedance			8		Ω
REFERENC	E INPUT BUFFER (REFBUF)					
External refe	erence voltage			1.2		V
EXTERNAL	VOLTAGE REFERENCE (VREF)		I			
V <sub>REF</sub>	External voltage reference			1.6		V
Input Curren	t			0.3		mA
Input impeda	ance			5.3		kΩ
CLOCK INP	UT (CLKP/M)					
Input clock f	requency		0.5		65	MHz
V <sub>ID</sub>	Differential input voltage			1	3.6	Vpp
V <sub>CM</sub>	Input common mode voltage			0.9		V
R <sub>IN</sub>	Single ended input resistance to co	ommon mode.		5		kΩ
C <sub>IN</sub>	Single ended input capacitance			1.5		pF
Clock duty c	ycle		40	50	60	%



# 6.6 Electrical Characteristics - DC Specifications (continued)

Typical values are over the operating free-air temperature range, at  $T_A = 25^{\circ}$ C, full temperature range is  $T_{MIN} = -40^{\circ}$ C to  $T_{MAX} = 105^{\circ}$ C, ADC sampling rate = 65 MSPS, 50% clock duty cycle, AVDD = IOVDD = 1.8 V, external 1.6 V reference, and -1-dBFS differential input, unless otherwise noted

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
DIGITAL	INPUTS (RESET, PDN, SCLK, SEN,	SDIO)				
VIH	High level input voltage		1.4			V
V <sub>IL</sub>	Low level input voltage				0.4	V
I <sub>IH</sub>	High level input current			90	150	uA
IIL	Low level input current		-150	-90		uA
CI	Input capacitance	Input capacitance				pF
DIGITAL	OUTPUT (SDOUT)					
V <sub>OH</sub>	High level output voltage	I <sub>LOAD</sub> = -400 uA	IOVDD - 0.1	IOVDD		V
V <sub>OL</sub>	Low level output voltage	I <sub>LOAD</sub> = 400 uA			0.1	V
DIGITAL	SCMOS OUTPUTS (DA5/6, DB5/6)					
Output da	ata rate				250	MHz
V <sub>OH</sub>	High level output voltage	per CMOS output pin	IOVDD - 0.1	IOVDD		V
V <sub>OL</sub>	Low level output voltage	I <sub>LOAD</sub> = 400 uA			0.1	V
V <sub>IH</sub>	High level input voltage	DCLKIN	IOVDD - 0.1	IOVDD		V
V <sub>IL</sub>	Low level input voltage				0.1	V

(1) Performance data shown is prior to decimation filtering. With DDC enabled, performance improves by the decimation filtering process.

### 6.7 Electrical Characteristics - AC Specifications

Typical values are over the operating free-air temperature range, at  $T_A = 25^{\circ}$ C, full temperature range is  $T_{MIN} = -40^{\circ}$ C to  $T_{MAX} = 105^{\circ}$ C, ADC sampling rate = 65 MSPS, 50% clock duty cycle, AVDD = IOVDD = 1.8 V, external 1.6 V reference, and -1-dBFS differential input, unless otherwise noted

PARAMETER		TEST CONDITIONS	MIN	ТҮР	MAX	UNIT	
NSD	Noise Spectral Density	f <sub>IN</sub> = 1.1 MHz, A <sub>IN</sub> = -20 dBFS		-159		dBFS/Hz	
		f <sub>IN</sub> = 1.1 MHz		82.0			
		f <sub>IN</sub> = 5 MHz	77.5	81.9			
SNR <sup>(1)</sup>	Signal to poise ratio	f <sub>IN</sub> = 10 MHz		81.2		dBFS	
SINK	Signal to noise ratio	f <sub>IN</sub> = 20 MHz		79.9		UDFS	
		f <sub>IN</sub> = 40 MHz		77.6			
		f <sub>IN</sub> = 64 MHz		74.6			
	Signal to noise ratio, complex decimation by 16	f <sub>IN</sub> = 1.1 MHz, f <sub>NCO</sub> = 2.5 MHz		88.3			
		f <sub>IN</sub> = 5 MHz, f <sub>NCO</sub> = 5 MHz		89.2			
SNR		$f_{IN}$ = 10 MHz, $f_{NCO}$ = 10 MHz		89.3		dBFS	
SNIX		$f_{IN}$ = 20 MHz, $f_{NCO}$ = 20 MHz		88.7		ubr 5	
		$f_{IN}$ = 40 MHz, $f_{NCO}$ = 40 MHz		86.5			
		$f_{IN}$ = 64 MHz, $f_{NCO}$ = 62.6 MHz		84.3			
		f <sub>IN</sub> = 1.1 MHz		80.0			
		f <sub>IN</sub> = 5 MHz	76.2	80.9			
SINAD <sup>(1)</sup>	Signal to noise and distortion ratio	f <sub>IN</sub> = 10 MHz		80.8		dBFS	
SINAD	Signal to noise and distortion ratio	f <sub>IN</sub> = 20 MHz		78.1		UDF3	
		f <sub>IN</sub> = 40 MHz		76.2			
		f <sub>IN</sub> = 64 MHz		73.6			



#### 6.7 Electrical Characteristics - AC Specifications (continued)

Typical values are over the operating free-air temperature range, at  $T_A = 25^{\circ}$ C, full temperature range is  $T_{MIN} = -40^{\circ}$ C to  $T_{MAX} = 105^{\circ}$ C, ADC sampling rate = 65 MSPS, 50% clock duty cycle, AVDD = IOVDD = 1.8 V, external 1.6 V reference, and -1-dBFS differential input, unless otherwise noted

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
		f <sub>IN</sub> = 1.1 MHz		13.3		
		f <sub>IN</sub> = 5 MHz	12.6	13.3		
		f <sub>IN</sub> = 10 MHz		13.2		L :4
ENOB <sup>(1)</sup>	Effective number of bits	f <sub>IN</sub> = 20 MHz		13.0		bit
		f <sub>IN</sub> = 40 MHz		12.6		
		f <sub>IN</sub> = 64 MHz		12.1		
		f <sub>IN</sub> = 1.1 MHz		83		
		f <sub>IN</sub> = 5 MHz	81	87		
THD <sup>(1)</sup>	Total Harmonic Distortion (First five	f <sub>IN</sub> = 10 MHz		90		dBc
	harmonics)	f <sub>IN</sub> = 20 MHz		82		ивс
		f <sub>IN</sub> = 40 MHz		81		
		f <sub>IN</sub> = 64 MHz		80		
	Spur free dynamic range including second and third harmonic	f <sub>IN</sub> = 1.1 MHz		84		
		f <sub>IN</sub> = 5 MHz	83	88		
SFDR <sup>(1)</sup>		f <sub>IN</sub> = 10 MHz		94		dBc
SFUR		f <sub>IN</sub> = 20 MHz		85		
		f <sub>IN</sub> = 40 MHz		83		
		f <sub>IN</sub> = 64 MHz		84		dBc
		f <sub>IN</sub> = 1.1 MHz		101		
		f <sub>IN</sub> = 5 MHz	91	102		
Non HD2,3 <sup>(1)</sup>	Spur free dynamic range (excluding	f <sub>IN</sub> = 10 MHz		99		
	HD2 and HD3)	f <sub>IN</sub> = 20 MHz		95		dBFS
		f <sub>IN</sub> = 40 MHz		93		
		f <sub>IN</sub> = 64 MHz		87		
		$f_1 = 3 \text{ MHz}, f_2 = 4 \text{ MHz}, A_{IN} = -7 \text{ dBFS}/$ tone		88		
IMD3	Two tone inter-modulation distortion	f <sub>1</sub> = 10 MHz, f <sub>2</sub> = 12 MHz, A <sub>IN</sub> = -7 dBFS/tone		90		dBc

(1) Performance data shown is prior to decimation filtering. With DDC enabled, performance improves by the decimation filtering process.



# 6.8 Timing Requirements

Typical values are over the operating free-air temperature range, at  $T_A = 25^{\circ}$ C, full temperature range is  $T_{MIN} = -40^{\circ}$ C to  $T_{MAX} = 105^{\circ}$ C, ADC sampling rate = 65 MSPS, 50% clock duty cycle, AVDD = IOVDD = 1.8 V, external 1.6 V reference, 5 pF output load, and -1-dBFS differential input, unless otherwise noted

PARAMETER		TEST CONDITIONS	MIN NOM	MAX	UNIT	
ADC TIMI	NG SPECIFICATIONS	,	· · · · · · · · · · · · · · · · · · ·			
t <sub>AD</sub>	Aperture Delay		0.85		ns	
t <sub>A</sub>	Aperture Jitter	square wave clock with fast edges	180		fs	
t <sub>J</sub>	Jitter on DCLKIN			± 50	ps pk-pk	
t <sub>ACQ</sub>	Signal acquisition period, Default	referenced to sampling clock falling edge	-T <sub>S</sub> /4		Sampling Clock Period	
t <sub>CONV</sub>	Signal conversion period	referenced to sampling clock falling edge	10		ns	
		Bandgap reference enabled, single ended clock	14.6		us	
	Time to valid data after coming out of power down. Internal reference.	Bandgap reference enabled, differential clock	1.7			
Wake up		Bandgap reference disabled, single ended clock			ms	
		Bandgap reference disabled, differential clock				
time		Bandgap reference enabled, single ended clock	14.6		us	
	Time to valid data after coming out of power	Bandgap reference enabled, differential clock	ck 14.0		1	
	down. External 1.6V reference.	Bandgap reference disabled, single ended clock	1.8		ms	
		Bandgap reference disabled, differential clock	1.7			
t <sub>S,SYNC</sub>	Setup time for SYNC input signal	Referenced to sampling clock rising edge	500		20	
t <sub>H,SYNC</sub>	Hold time for SYNC input signal	- Referenced to sampling clock fising edge	600		ps	
		Serialized CMOS: 2-wire	2		ADC	
ADC Latency	Signal input to data output	Serialized CMOS: 1-wire 1			clock	
Latonoy		Serialized CMOS: 1/2-wire	1		cycles	
	Real decimation by 2		21		Output	
Add. Latency	Complex decimation by 2		22		clock	
	Real or complex decimation by 4, 8, 16, 32		23		cycles	



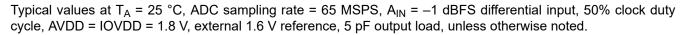
#### 6.8 Timing Requirements (continued)

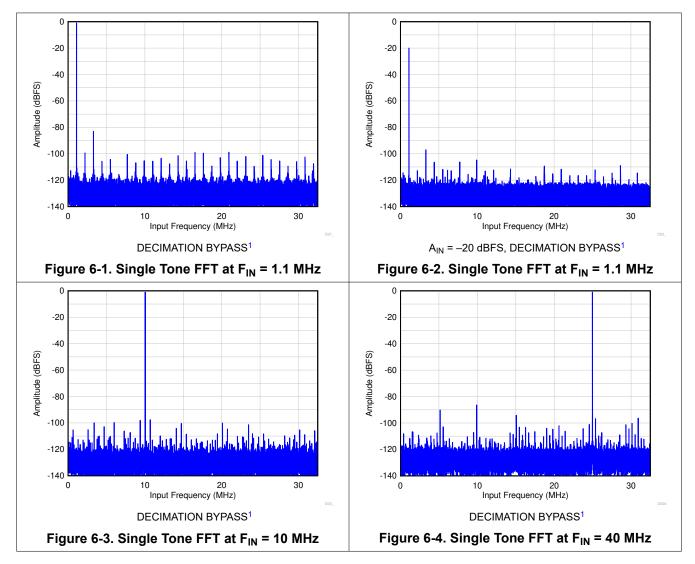
Typical values are over the operating free-air temperature range, at  $T_A = 25^{\circ}$ C, full temperature range is  $T_{MIN} = -40^{\circ}$ C to  $T_{MAX} = 105^{\circ}$ C, ADC sampling rate = 65 MSPS, 50% clock duty cycle, AVDD = IOVDD = 1.8 V, external 1.6 V reference, 5 pF output load, and -1-dBFS differential input, unless otherwise noted

	PARAMETER	TEST CONDITIONS	MIN	NOM	MAX	UNIT
INTERFAC	CE TIMING					
	Propagation delay: sampling clock falling edge to DCLK rising edge	$\label{eq:constraint} \begin{array}{ c c c } \hline Delay between sampling clock falling edge to \\ DCLKIN falling edge < 2.5ns. \\ \hline T_{DCLK} = DCLK period \\ \hline t_{CDCLK} = Sampling clock falling edge to \\ DCLKIN falling edge \end{array}$	T <sub>DCLK</sub>	3 + T <sub>DCLK</sub> + t <sub>CDCLK</sub>	+	
t <sub>PD</sub>		Delay between sampling clock falling edge to DCLKIN falling edge >= 2.5ns. $T_{DCLK}$ = DCLK period $t_{CDCLK}$ = Sampling clock falling edge to DCLKIN falling edge	2 + t <sub>CDCLK</sub>	3 + t <sub>CDCLK</sub>	4 + t <sub>CDCLK</sub>	ns
		Fout = 10 MSPS, DA/B5,6 = 80 MBPS	-0.24	0.10		
	DCLK rising edge to output data delay 2-wire serial CMOS	Fout = 20 MSPS, DA/B5,6 = 160 MBPS	-0.29	0.10		
		Fout = 30 MSPS, DA/B5,6 = 240 MBPS	-0.28	0.09		
t <sub>CD</sub>		Fout = 5 MSPS, DA/B6 = 80 MBPS	-0.22	0.11		ns
CD	DCLK rising edge to output data delay 1-wire serial CMOS	Fout = 10 MSPS, DA/B6 = 160 MBPS	-0.27	0.11		
		Fout = 15 MSPS, DA/B6 = 240 MBPS	-0.52	0.08		
	DCLK rising edge to output data delay 1/2-wire serial CMOS	Fout = 5 MSPS, DA6 = 160 MBPS	-0.24	0.1		
	Data valid, 2-wire serial CMOS	Fout = 10 MSPS, DA/B5,6 = 80 MBPS	12.19	12.36		
		Fout = 20 MSPS, DA/B5,6 = 160 MBPS	5.93	6.1		
		Fout = 30 MSPS, DA/B5,6 = 240 MBPS	3.91	4.07		
t <sub>DV</sub>		Fout = 5 MSPS, DA/B6 = 80 MBPS	12.21	12.39		ns
	Data valid, 1-wire serial CMOS	Fout = 10 MSPS, DA/B6 = 160 MBPS	5.95	6.10		
		Fout = 15 MSPS, DA/B6 = 240 MBPS	3.83	4.08		
	Data valid, 1/2-wire serial CMOS	Fout = 5 MSPS, DA6 = 160 MBPS	5.36	6.13		
SERIAL P	ROGRAMMING INTERFACE (SCLK, SEN, SD	DIO) - Input				
f <sub>CLK,SCLK</sub>	Serial clock frequency				20	MHz
t <sub>S,SEN</sub>	SEN falling edge to SCLK rising edge		10			
t <sub>H,SEN</sub>	SCLK rising edge to SEN rising edge		9			20
t <sub>s,sDIO</sub>	SDIO setup time from rising edge of SCLK		17			ns
t <sub>H,SDIO</sub>	SDIO hold time from rising edge of SCLK		9			
SERIAL P	ROGRAMMING INTERFACE (SDIO) - Output	·				
t <sub>OZD</sub>	Delay from falling edge of 16th SCLK cycle du tri-state to valid data	ring read operation for SDIO transition from	3.9		10.8	
t <sub>ODZ</sub>	Delay from SEN rising edge for SDIO transitio	n from valid data to tri-state	3.4		14	ns
t <sub>OD</sub>	Delay from falling edge of 16th SCLK cycle du	ring read operation to SDIO valid	3.9		10.8	



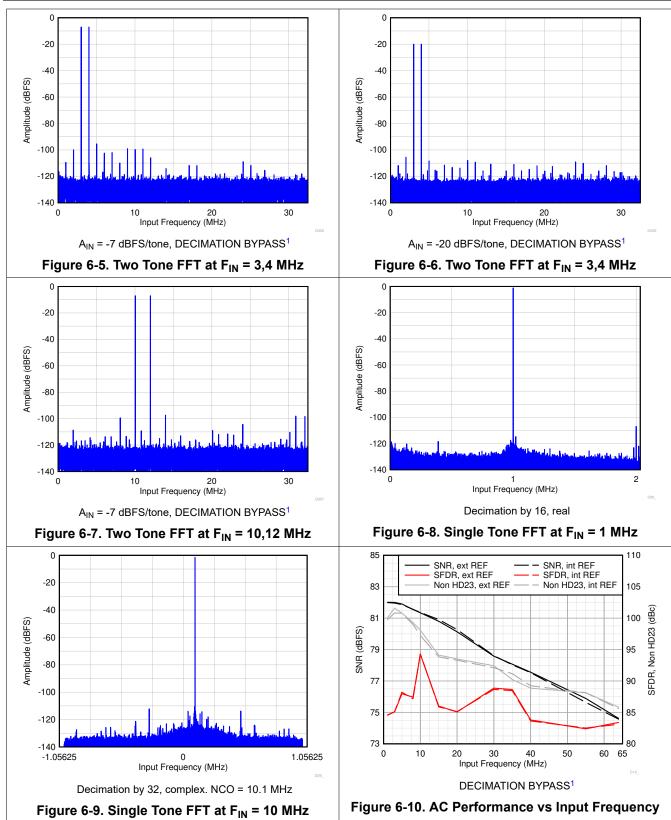
### **6.9 Typical Characteristics**





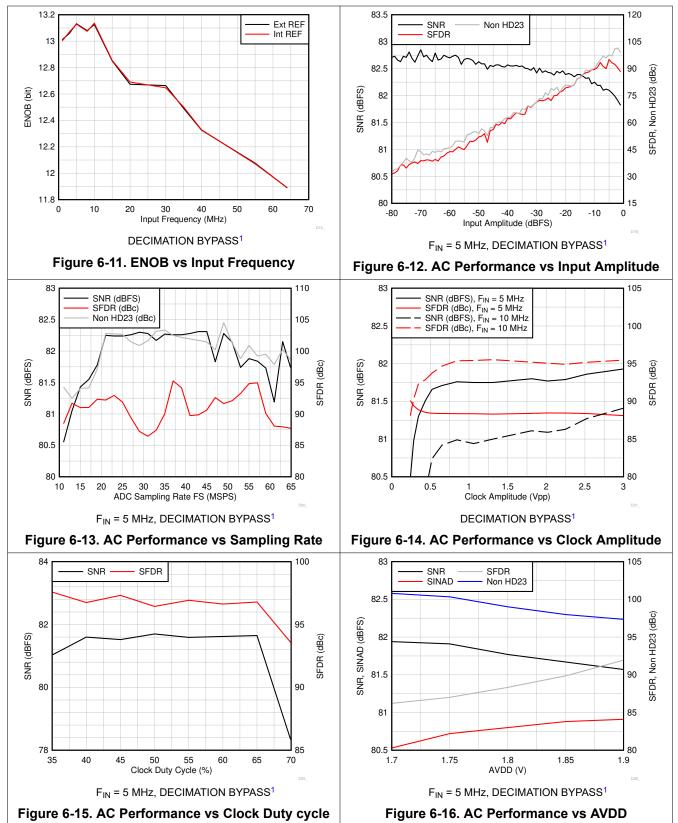
<sup>&</sup>lt;sup>1</sup> Decimation bypass mode is for full Nyquist zone illustration only.



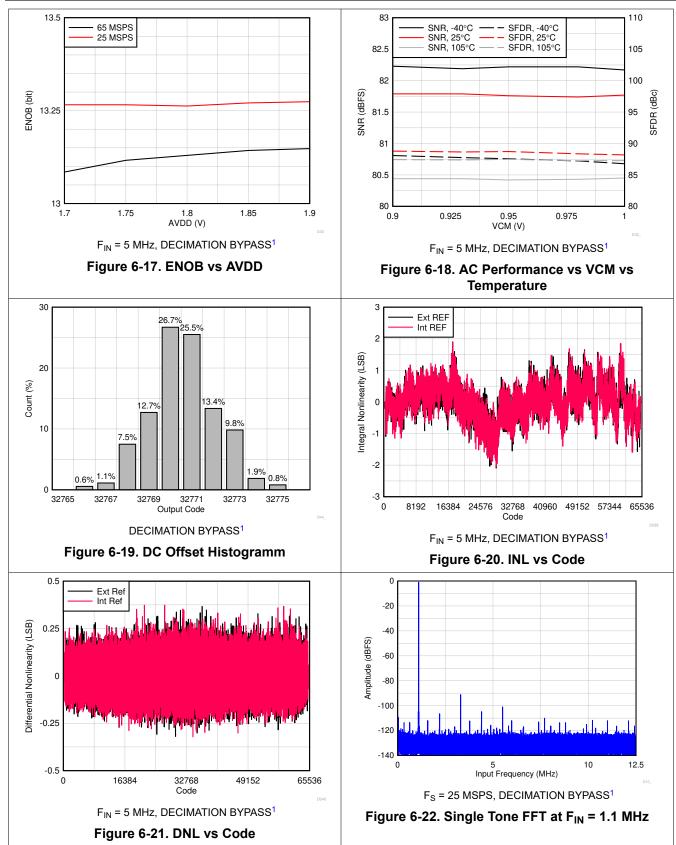


ADC3660 SBASA01B – SEPTEMBER 2020 – REVISED MARCH 2022



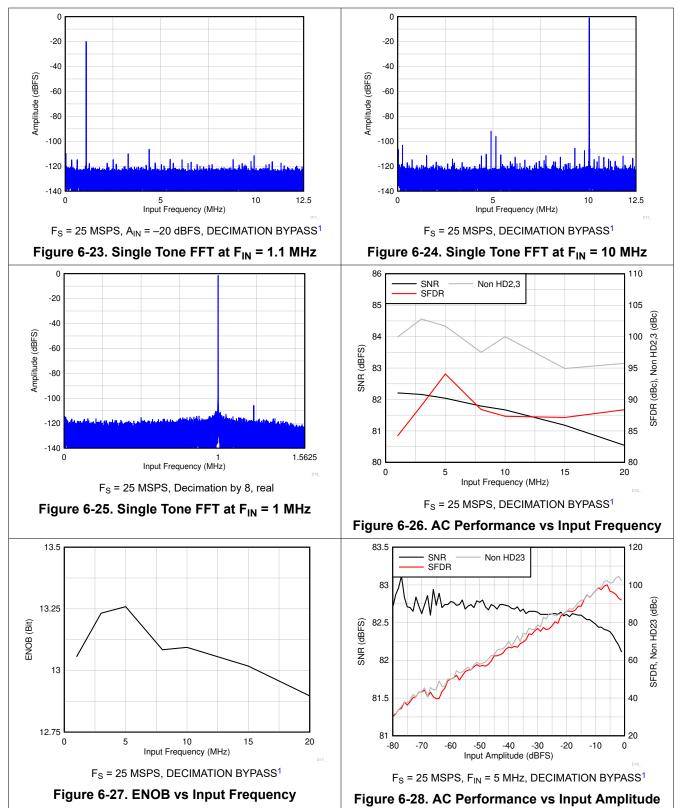




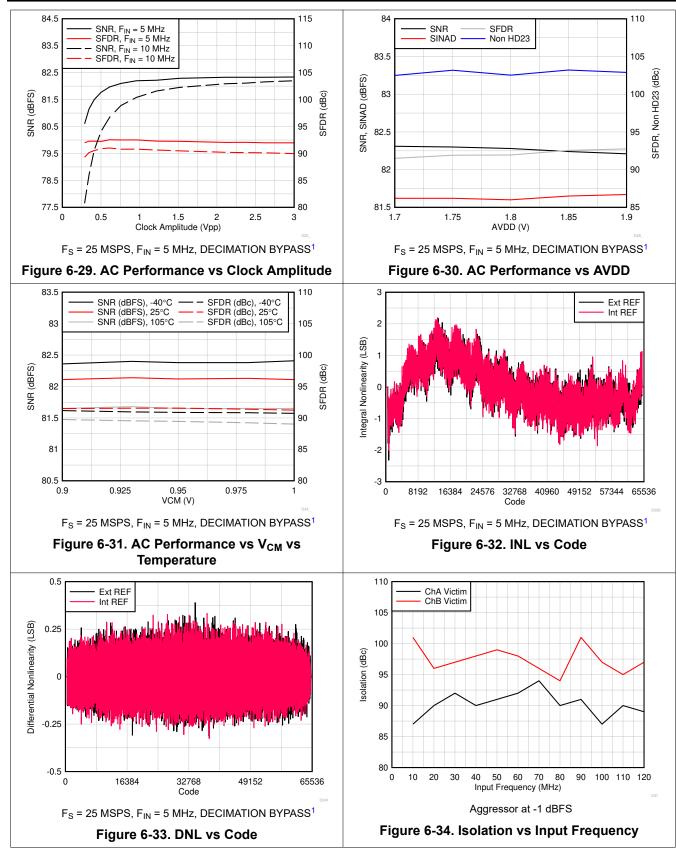


ADC3660 SBASA01B – SEPTEMBER 2020 – REVISED MARCH 2022



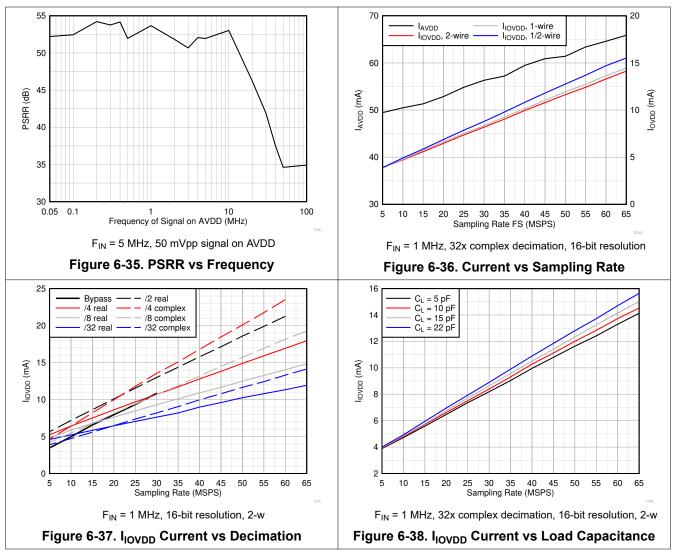






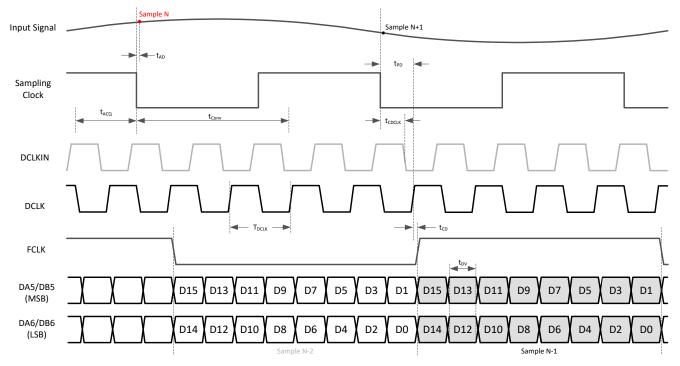
ADC3660 SBASA01B – SEPTEMBER 2020 – REVISED MARCH 2022







### 7 Parameter Measurement Information





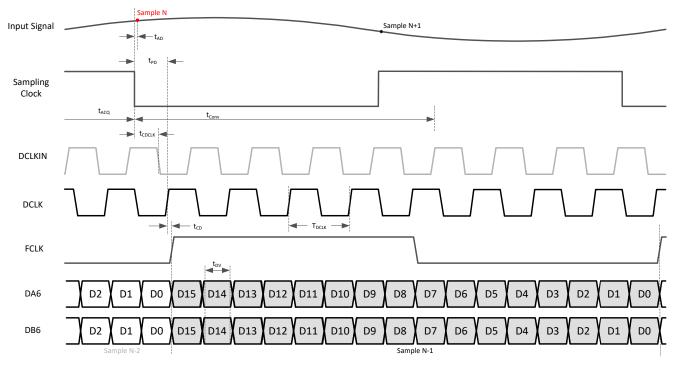


Figure 7-2. Timing diagram: 1-wire SCMOS (changed from 18-bit to 16-bit output after power up)



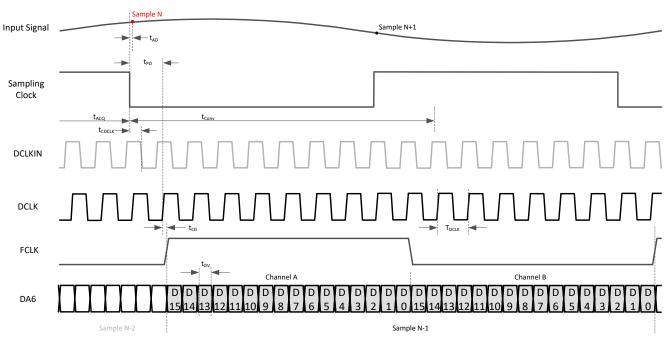


Figure 7-3. Timing diagram: 1/2-wire SCMOS (changed from 18-bit to 16-bit output after power up)



# 8 Detailed Description

#### 8.1 Overview

The ADC3660 is a low noise, ultra-low power 16-bit high-speed dual channel ADC family supporting sampling rates up to 65Msps. It offers excellent DC precision together with IF sampling support which makes it ideally suited for a wide range of applications. The ADC3660 is equipped with an internal reference option but it also supports the use of an external, high precision 1.6V voltage reference or an external 1.2V reference which is buffered and gained up internally.

An optional programmable digital down converter enables external anti-alias filter relaxation as well as output data rate reduction. The digital filter provides a 32-bit programmable NCO and supports both real or complex decimation.

#### Note

The ADC3660 uses a serial CMOS (SCMOS) interface to output the data which minimizes the number of digital interconnects. The device supports a two-lane (2-wire), a one-lane (1-wire) and a half lane (1/2-wire) interface option. The serialized CMOS interface supports output rates up to 250Mbps which translates to the following maximum output rates:

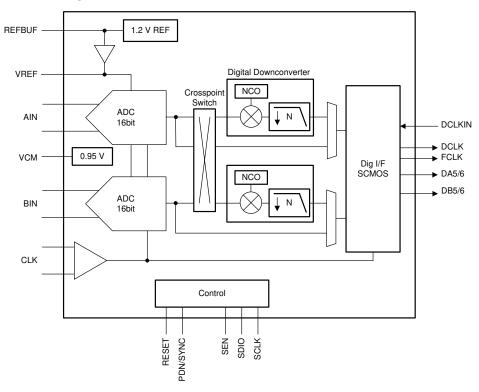
- Decimation Bypass Mode: ~ 31 Msps (2-wire) to ~ 8 Msps (0.5-wire)
- Complex Decimation: ~ 15 Msps (2-wire) to ~4 Msps (0.5-wire)
- Real Decimation: ~ 30 Msps (2-wire) to ~ 8 Msps (0.5-wire)

Hence the ADC3660 can be operated in 'oversampling and decimating' mode using the internal decimation filter in order to improve the dynamic range and relax external anti-aliasing filter.

The ADC3660 includes a digital output formatter which supports output resolutions from 14 to 20-bit.

The device features and control options can be set up either through pin configurations or via SPI register writes.

#### 8.2 Functional Block Diagram





#### 8.3 Feature Description

#### 8.3.1 Analog Input

The analog inputs of ADC3660 are intended to be driven differentially. Both AC coupling and DC coupling of the analog inputs is supported. The analog inputs are designed for an input common mode voltage of 0.95 V which must be provided externally on each input pin. DC-coupled input signals must have a common mode voltage that meets the device input common mode voltage range.

The equivalent input network diagram is shown in Figure 8-1. All four sampling switches, on-resistance shown in red, are in same position (open or closed) simultaneously.

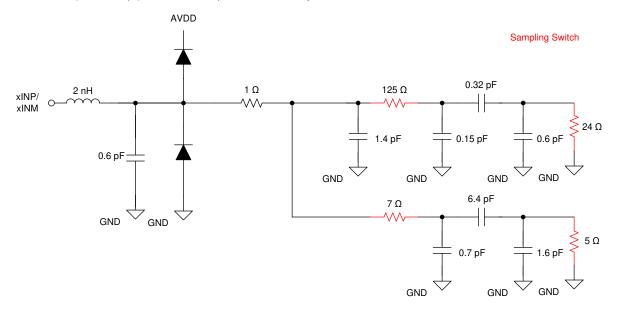
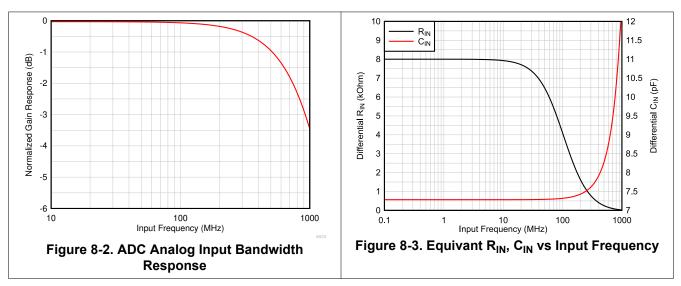


Figure 8-1. Equivalent Input Network

#### 8.3.1.1 Analog Input Bandwidth

Figure 8-2 shows the analog full power input bandwidth of the ADC3660 with a 50  $\Omega$  differential termination. The -3 dB bandwidth is approximately 900 MHz and the useful input bandwidth with good AC performance is approximately 120 MHz.

The equivalent differential input resistance  $R_{IN}$  and input capacitance  $C_{IN}$  vs frequency are shown in Figure 8-3.





#### 8.3.1.2 Analog Front End Design

The ADC3660 is an unbuffered ADC and thus a passive kick-back filter is recommended to absorb the glitch from the sampling operation. Depending on if the input is driven by a balun or a differential amplifier with low output impedance, a termination network may be needed. Additionally a passive DC bias circuit is needed in AC-coupled applications which can be combined with the termination network.

#### 8.3.1.2.1 Sampling Glitch Filter Design

The front end sampling glitch filter is designed to optimize the SNR and HD3 performance of the ADC. The filter performance is dependent on input frequency and therefore the following filter designs are recommended for different input frequency ranges as shown in Figure 8-4 and Figure 8-5 (assuming 50  $\Omega$  source impedance).

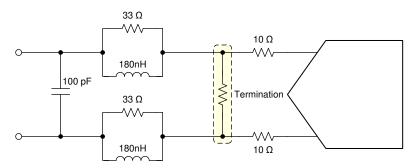


Figure 8-4. Sampling glitch filter for input frequencies from DC to 30 MHz

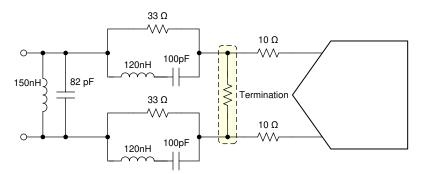


Figure 8-5. Sampling glitch filter for input frequencies from 30 to 70 MHz



#### 8.3.1.2.2 Analog Input Termination and DC Bias

Depending on the input drive circuitry, a termination network and/or DC biasing needs to be provided.

#### 8.3.1.2.2.1 AC-Coupling

The ADC3660 requires external DC bias using the common mode output voltage (VCM) of the ADC together with the termination network as shown in Figure 8-6. The termination is located within the glitch filter network. When using a balun on the input, the termination impedance has to be adjusted to account for the turns ratio of the transformer. When using an amplifier, the termination impedance can be adjusted to optimize the amplifier performance.

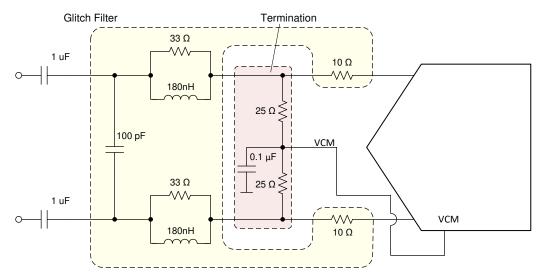
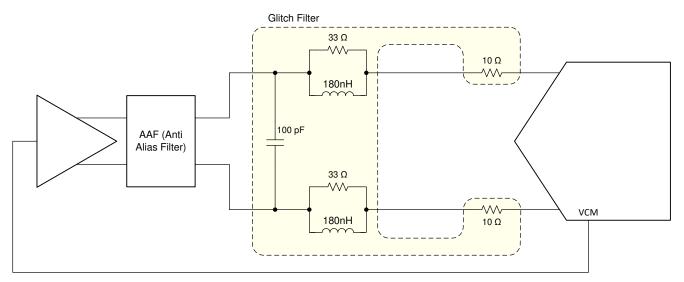
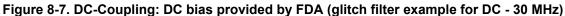


Figure 8-6. AC-Coupling: termination network provides DC bias (glitch filter example for DC - 30 MHz)

#### 8.3.1.2.2.2 DC-Coupling

In DC coupled applications the DC bias needs to be provided from the fully differential amplifier (FDA) using VCM output of the ADC as shown in Figure 8-7. The glitch filter in this case is located between the anti-alias filter and the ADC. No termination may be needed if amplifier is located close to the ADC or if the termination is part of the anti-alias filter.

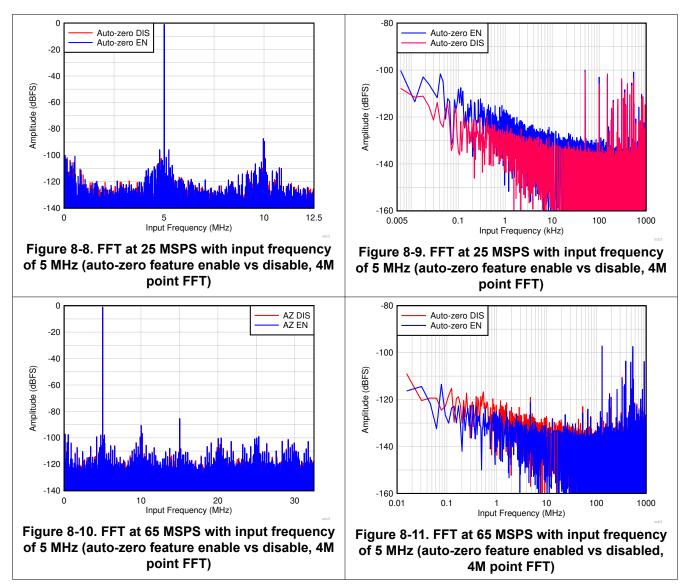






### 8.3.1.3 Auto-Zero Feature

The ADC3660 includes an internal auto-zero front end amplifier circuit which improves the 1/f flicker noise. This auto-zero feature can be enabled using SPI register writes (register 0x11, D0).





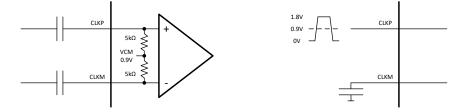
#### 8.3.2 Clock Input

In order to maximize the ADC SNR performance, the external sampling clock should be low jitter and differential signaling with a high slew rate. This is especially important in IF sampling applications. For less jitter sensitive applications, the ADC3660 provides the option to operate with single ended signaling which saves additional power consumption.

#### 8.3.2.1 Single Ended vs Differential Clock Input

The ADC3660 can be operated using a differential or a single ended clock input where the single ended clock consumes less power consumption. However clock amplitude impacts the ADC aperture jitter and consequently the SNR. For maximum SNR performance, a large clock signal with fast slew rates needs to be provided.

- Differential Clock Input: The clock input can be AC coupled externally. The ADC3660 provides internal biasing for that use case.
- ingle Ended Clock Input: This mode needs to be configured using SPI register (0x0E, D2 and D0) or with the REFBUF pin. In this mode there is no internal clock biasing and thus the clock input needs to be DC coupled around a 0.9V center. The unused input needs to be AC coupled to ground.



#### Figure 8-12. External and internal connection using differential (left) and single ended (right) clock input

#### 8.3.2.2 Signal Acquisition Time Adjust

The ADC3660 includes a register (DLL PDN (0x11, D2) which increases the signal acquisition time window for clock rates below 40 MSPS from 25% to 50% of the clock period. Increasing the sampling time provides a longer time for the driving amplifier to settle out the signal which can improve the SNR performance of the system. When powering down the DLL, the acquisition time will track the clock duty cycle (50% is recommended).

SAMPLING CLOCK F <sub>S</sub> (MSPS)	DLL PDN (0x11, D2)	ACQUISITION TIME (t <sub>ACQ</sub> )
65	0	T <sub>S</sub> / 4
≤ 40	1	T <sub>S</sub> / 2

#### Table 8-1. Acquisition time vs DLL PDN setting

T<sub>S</sub>: Sampling clock period



#### 8.3.3 Voltage Reference

The ADC3660 provides three different options for supplying the voltage reference to the ADC. An external 1.6V reference can be directly connected to the VREF input; a voltage 1.2V reference can be connected to the REFBUF input using the internal gain buffer or the internal 1.2V reference can be enabled to generate a 1.6V reference voltage. For best performance, the reference noise should be filtered by connecting a 10 uF and a 0.1 uF ceramic bypass capacitor to the VREF pin. The internal reference circuitry of the ADC3660 is shown in Figure 8-13.

#### Note

The voltage reference mode can be selected using SPI register writes or by using the REFBUF pin (default) as a control pin (Section 8.5.1). If the REFBUF pin is not used for configuration, the REFBUF pin should be connected to AVDD (even though the REFBUF pin has a weak internal pullup to AVDD) and the voltage reference option has to be selected using the SPI interface.

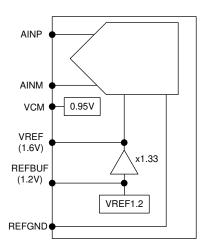


Figure 8-13. Different voltage reference options for ADC3660

#### 8.3.3.1 Internal voltage reference

The 1.6V reference for the ADC can be generated internal using the on-chip 1.2V bandgap reference along with the internal gain buffer. A 10 uF and a 0.1 uF ceramic bypass capacitor ( $C_{VREF}$ ) should be connected between the VREF and REFGND pins as close to the pins as possible.

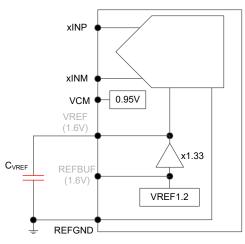


Figure 8-14. Internal reference



#### 8.3.3.2 External voltage reference (VREF)

For highest accuracy and lowest temperature drift, the VREF input can be directly connected to an external 1.6V reference. A 10 uF and a 0.1 uF ceramic bypass capacitor ( $C_{VREF}$ ) should connected between the VREF and REFGND pins and placed as close to the pins as possible is recommended. The load current from the external reference is about 1mA.

Note: The internal reference is also used for other functions inside the device, therefore the reference amplifier should only be powered down in power down state but not during normal operation.

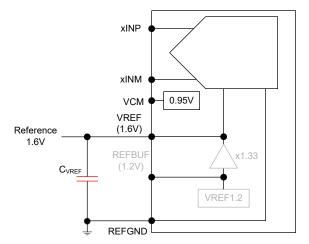


Figure 8-15. External 1.6V reference

#### 8.3.3.3 External voltage reference with internal buffer (REFBUF)

The ADC3660 is equipped with an on-chip reference buffer that also includes gain to generate the 1.6V reference voltage from an external 1.2V reference. A 10 uF and a 0.1 uF ceramic bypass capacitor ( $C_{VREF}$ ) between the VREF and REFGND pins and a 10 uF and a 0.1 uF ceramic bypass capacitor between the REFBUF and REFGND pins are recommended. Both capacitors should be placed as close to the pins as possible. The load current from the external reference is less than 100uA.

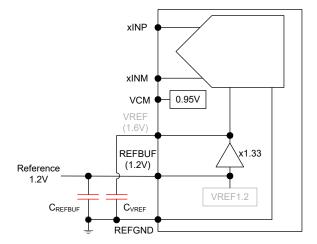


Figure 8-16. External 1.2V reference using internal reference buffer



#### 8.3.4 Digital Down Converter

The ADC3660 includes an optional on-chip digital down conversion (DDC) decimation filter that can be enabled via SPI register setting. It supports complex decimation by 2, 4, 8, 16 and 32 using a digital mixer and a 32-bit numerically controlled oscillator (NCO) as shown in Figure 8-17. Furthermore it supports a mode with real decimation where the complex mixer is bypassed (NCO should be set to 0 for lowest power consumption) and the digital filter acts as a low pass filter.

Internally the decimation filter calculations are performed with a 20-bit resolution in order to avoid any SNR degradation due to quantization noise limitation. The output formatter truncates to the selected resolution prior to outputting the data on the digital interface.

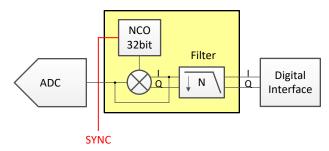


Figure 8-17. Internal Digital Decimation Filter

#### 8.3.4.1 DDC MUX

The ADC3660 contains a MUX in front of the digital decimation filters which allows ADC ChA to be connected to DDC ChB and vice versa.

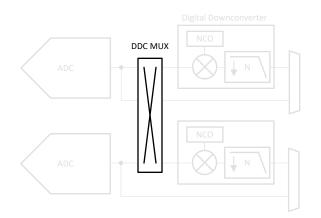
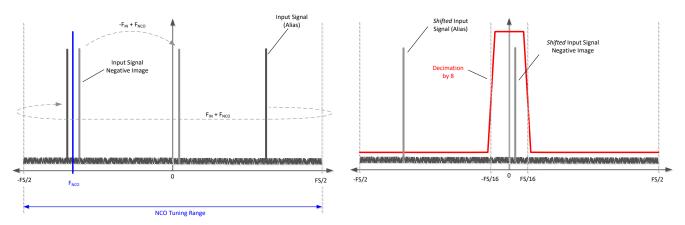


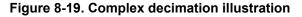
Figure 8-18. DDC MUX



#### 8.3.4.2 Digital Filter Operation

The complex decimation operation is illustrated with an example in Figure 8-19. First the input signal (and the negative image) are frequency shifted by the NCO frequency as shown on the left. Next a digital filter is applied (centered around 0 Hz) and the output data rate is decimated - in this example the output data rate  $F_{S,OUT} = F_S/8$  with a Nyquist zone of  $F_S/16$ . During the complex mixing the spectrum (signal and noise) is split into real and complex parts and thus the amplitude is reduced by 6-dB. In order to compensate this loss, there is a 6-dB digital gain option in the decimation filter block that can be enabled via SPI write.





The real decimation operation is illustrated with an example in Figure 8-20. There is no frequency shift happening and only the real portion of the complex digital filter is exercised. The output data rate is decimated - a decimation of 8 would result in an output data rate  $F_{S,OUT} = F_S/8$  with a Nyquist zone of  $F_S/16$ .

During the real mixing the spectrum (signal and noise) amplitude is reduced by 3-dB. In order to compensate this loss, there is a 3-dB digital gain option in the decimation filter block that can be enabled via SPI write.

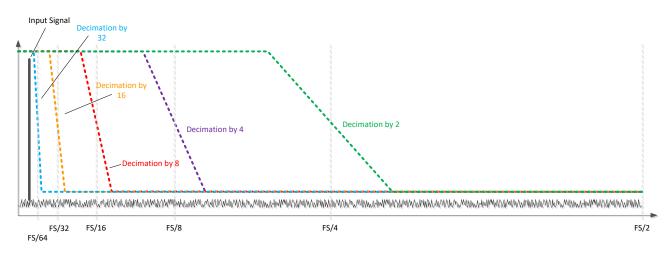


Figure 8-20. Real decimation illustration



#### 8.3.4.2.1 FS/4 Mixing with Real Output

In this mode, the output after complex decimation gets mixed with FS/4 (FS = output data rate in this case). Instead of a complex output with the input signal centered around 0 Hz, the output is transmitted as a real output at twice the data rate and the signal is centered around FS/4 (Fout/4) as illustrated in Figure 8-21.

In this example, complex decimation by 8 is used. The output data is transmitted as a real output with an output rate of Fout = FS'/4 (FS' = ADC sampling rate). The input signal is now centered around FS/4 (Fout/4) or FS'/16.

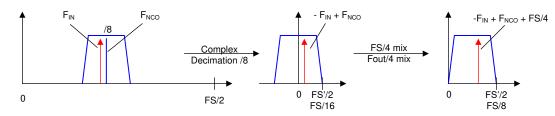


Figure 8-21. FS/4 Mixing with real output

#### 8.3.4.3 Numerically Controlled Oscillator (NCO) and Digital Mixer

The decimation block is equipped with a 32-bit NCO and a digital mixer to fine tune the frequency placement prior to the digital filtering. The oscillator generates a complex exponential sequence of:

 $e^{j\omega n}$  (default) or  $e^{-j\omega n}$ 

(1)

where: frequency ( $\omega$ ) is specified as a signed number by the 32-bit register setting

The complex exponential sequence is multiplied with the real input from the ADC to mix the desired carrier to a frequency equal to  $f_{IN} + f_{NCO}$ . The NCO frequency can be tuned from  $-F_S/2$  to  $+F_S/2$  and is processed as a signed, 2s complement number. After programming a new NCO frequency, the mixer restart register bits (0x26, D4/D1) or SYNC pin has to be toggled for the new frequency to get active. Additionally the ADC3660 provides the option via SPI to invert the mixer phase. The NCO frequency setting is set by the 32-bit register value given and calculated as:

NCO frequency = 0 to +  $F_S/2$ : NCO =  $f_{NCO} \times 2^{32} / F_S$ 

NCO frequency =  $-F_S/2$  to 0: NCO =  $(f_{NCO} + F_S) \times 2^{32} / F_S$ 

where:

- NCO = NCO register setting (decimal value)
- f<sub>NCO</sub> = Desired NCO frequency (MHz)
- F<sub>S</sub> = ADC sampling rate (MSPS)

The NCO programming is further illustrated with this example:

- ADC sampling rate  $F_S = 65$  MSPS
- Input signal f<sub>IN</sub> = 10 MHz
- Desired output frequency f<sub>OUT</sub> = 0 MHz

For this example there are actually four ways to program the NCO and achieve the desired output frequency as shown in Table 8-2.

Alias or negative image	f <sub>NCO</sub>	NCO Value	Mixer Phase	Frequency translation for f <sub>OUT</sub>
f <sub>IN</sub> = –10 MHz	f <sub>NCO</sub> = 10 MHz	660764199	as is	$f_{OUT} = f_{IN} + f_{NCO} = -10 \text{ MHz} + 10 \text{ MHz} = 0 \text{ MHz}$
f <sub>IN</sub> = 10 MHz	f <sub>NCO</sub> = -10 MHz	3634203097	as 15	$f_{OUT} = f_{IN} + f_{NCO} = 10 \text{ MHz} + (-10 \text{ MHz}) = 0 \text{ MHz}$
f <sub>IN</sub> = 10 MHz	f <sub>NCO</sub> = 10 MHz	660764199	inverted	$f_{OUT} = f_{IN} - f_{NCO} = 10 \text{ MHz} - 10 \text{ MHz} = 0 \text{ MHz}$
f <sub>IN</sub> = –10 MHz	f <sub>NCO</sub> = -10 MHz	3634203097	invented	$f_{OUT} = f_{IN} - f_{NCO} = -10 \text{ MHz} - (-10 \text{ MHz}) = 0 \text{ MHz}$

Table 8-2.	NCO	value	calculations	example
------------	-----	-------	--------------	---------

#### 8.3.4.4 Decimation Filter

The ADC3660 supports complex decimation by 2, 4, 8, 16 and 32 with a pass-band bandwidth of ~ 80% and a stopband rejection of at least 85dB. Table 8-3 gives an overview of the pass-band bandwidth of the different decimation settings with respect to ADC sampling rate  $F_S$ . Note that the maximum output rate limits can't be exceeded and the ADC sampling rate may need to adjusted. In real decimation mode the output bandwidth is half of the complex bandwidth.

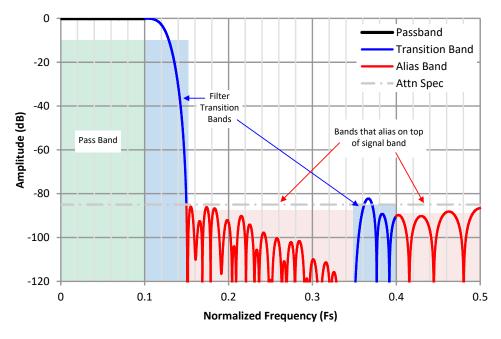
REAL/COMPLEXDECIMATIONDECIMATIONSETTING N		OUTPUT RATE	OUTPUT BANDWIDTH	OUTPUT RATE (F <sub>S</sub> = 65 MSPS)	OUTPUT BANDWIDTH (F <sub>S</sub> = 65 MSPS)
	2	F <sub>S</sub> / 2 complex	0.8 × F <sub>S</sub> / 2	32.5 MSPS complex	26 MHz
	4	F <sub>S</sub> / 4 complex	0.8 × F <sub>S</sub> / 4	16.25 MSPS complex	13 MHz
Complex	8	F <sub>S</sub> / 8 complex	0.8 × F <sub>S</sub> / 8	8.125 MSPS complex	6.5 MHz
	16	F <sub>S</sub> / 16 complex	0.8 × F <sub>S</sub> / 16	4.0625 MSPS complex	3.25 MHz
	32	F <sub>S</sub> / 32 complex	0.8 × F <sub>S</sub> / 32	2.03125 MSPS complex	1.625 MHz
	2	F <sub>S</sub> / 2 real	0.4 × F <sub>S</sub> / 2	32.5 MSPS	13 MHz
	4	F <sub>S</sub> / 4 real	0.4 × F <sub>S</sub> / 4	16.25 MSPS	6.5 MHz
Real	8	F <sub>S</sub> / 8 real	0.4 × F <sub>S</sub> / 8	8.125 MSPS	3.25 MHz
	16	F <sub>S</sub> / 16 real	0.4 × F <sub>S</sub> / 16	4.0625 MSPS	1.625 MHz
	32	F <sub>S</sub> / 32 real	0.4 × F <sub>S</sub> / 32	2.03125 MSPS	0.8125 MHz

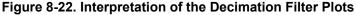
#### Table 8-3. Decimation Filter Summary and Maximum Available Output Bandwidth

The decimation filter responses normalized tot he ADC sampling clock frequency  $F_S$  are illustrated in Figure 8-23 to Figure 8-32. They are interpreted as follows:

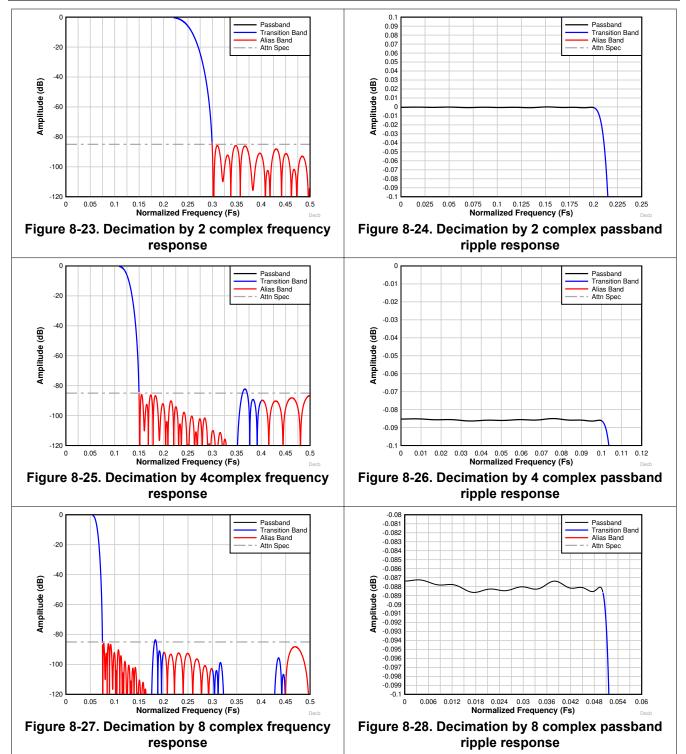
Each figure contains the filter pass-band, transition band(s) and alias or stop-band(s) as shown in Figure 8-22. The x-axis shows the offset frequency (after the NCO frequency shift) normalized to the ADC sampling rate  $F_S$ .

For example, in the divide-by-4 complex setup, the output data rate is  $F_S / 4$  complex with a Nyquist zone of  $F_S / 8$  or  $0.125 \times F_S$ . The transition band (colored in blue) is centered around  $0.125 \times F_S$  and the alias transition band is centered at  $0.375 \times F_S$ . The stop-bands (colored in red), which alias on top of the pass-band, are centered at  $0.25 \times F_S$  and  $0.5 \times F_S$ . The stop-band attenuation is greater than 85 dB.

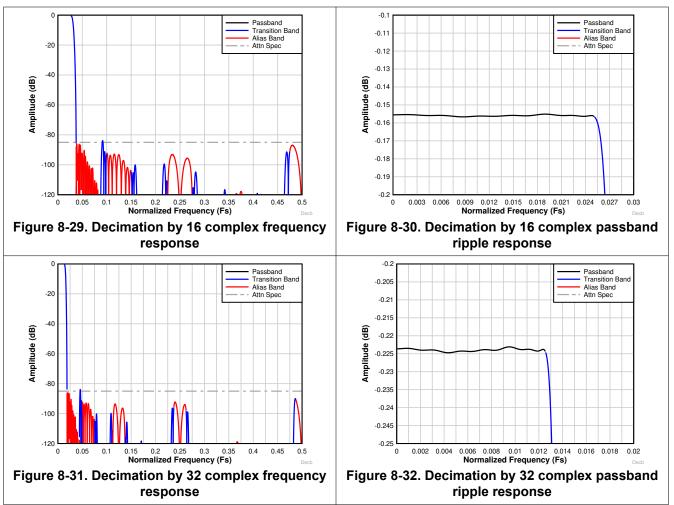












### 8.3.4.5 SYNC

The PDN/SYNC pin can be used to synchronize multiple devices using an external SYNC signal. The PDN/ SYNC pin can be configured via SPI (SYNC EN bit) from power down to synchronization functionality and is latched in by the rising edge of the sampling clock as shown in Figure 8-33.

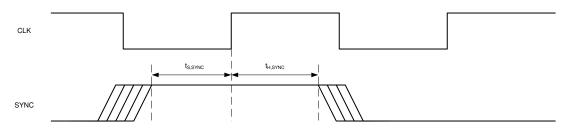


Figure 8-33. External SYNC timing diagram

The synchronization signal is only required when using the decimation filter - either using the SPI SYNC register or the PDN/SYNC pin. It resets internal clock dividers used in the decimation filter and aligns the internal clocks as well as I and Q data within the same sample. If no SYNC signal is given, the internal clock dividers is not be synchronized, which can lead to a fractional delay across different devices. The SYNC signal also resets the NCO phase and loads the new NCO frequency (same as the MIXER RESTART bit).

When trying to resynchronize during operation, the SYNC toggle should occur at 64\*K clock cycles, where K is an integer. This ensures phase continuity of the clock divider.



#### 8.3.4.6 Output Formatting with Decimation

When using decimation, the output data is formatted as shown in Figure 8-34 (complex decimation) and Figure 8-35 (real decimation). The interface data rates for 2-, 1- and 1/2-wire for complex output for different decimation settings are shown in Table 8-4.

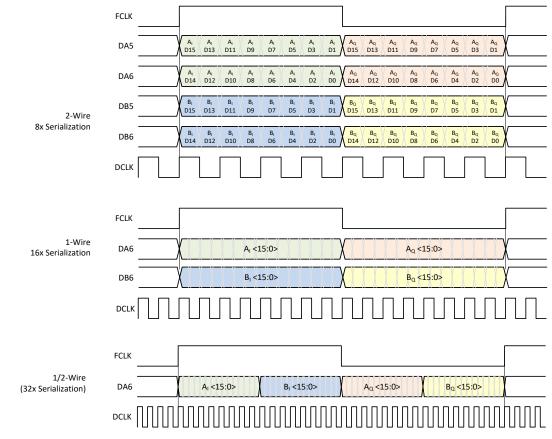


Figure 8-34. Output Data Format in Complex Decimation

Table 8-4 illustrates the output interface data rate along with the corresponding DCLK/DCLKIN and FCLK frequencies based on output resolution (R), number of SCMOS lanes (L) and complex decimation setting (N).

Furthermore the table shows an actual lane rate example for the 2-, 1- and 1/2-wire interface, 16-bit output resolution and complex decimation by 16.

DECIMATION SETTING	ADC SAMPLING RATE	OUTPUT RESOLUTION	# of WIRES	FCLK	DCLKIN, DCLK	DA/B5,6
N	F <sub>S</sub>	R	L	F <sub>S</sub> / N	[DA/B5,6] / 2	F <sub>S</sub> x2xR/L/N
	65 MSPS		2	40625 MHz	32.5 MHz	65 MHz
16			16	1	40023 10112	65 MHz
	62.5 MSPS		1/2	3.90625 MHz	125 MHz	250 MHz

Table 8-4. Serial CMOS Lane Rate Examples with Complex Decimation



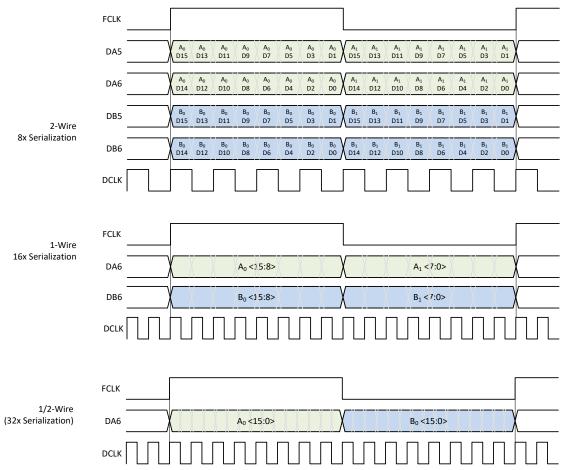


Figure 8-35. Output Data Format in Real Decimation

Table 8-5 illustrates the output interface data rate along with the corresponding DCLK/DCLKIN and FCLK frequencies based on output resolution (R), number of SCMOS lanes (L) and real decimation setting (M).

Furthermore the table shows an actual lane rate example for the 2-, 1- and 1/2-wire interface, 16-bit output resolution and real decimation by 16.

Table 0-5. Serial Omos Lane Nate Examples with Near Decimation							
DECIMATION SETTING	ADC SAMPLING RATE	OUTPUT RESOLUTION	# of WIRES	FCLK	DCLKIN, DCLK	DA/B5,6	
м	Fs	R	L	$F_{S} / M / 2 (L = 2)$ $F_{S} / M (L = 1, 1/2)$	[DA/B5,6] / 2	F <sub>S</sub> x R / L / M	
16	65 MSPS	16	2	2.03125 MHz	16.25 MHz	32.5 MHz	
			1	4.0625 MHz	32.5 MHz	65 MHz	
			1/2		65 MHz	130 MHz	

Table 8-5 Serial CMC	)S I ane Rate Exam	ples with Real Decimation
	JO LAHE NALE LAAIH	pies with real Declination



#### 8.3.5 Digital Interface

The serial CMOS interface supports the data output with 2-wire, 1-wire and 1/2-wire operation. The actual data output rate depends on the output resolution and number of lanes used.

The ADC3660 requires an external serial clock input (DCLKIN), which is used to transmit the data out of the ADC along with the data clock (DCLK). The phase relationship between DCLKIN and the sampling clock is irrelevant but both clocks need to be frequency locked. The serial CMOS interface is configured using SPI register writes.

#### 8.3.5.1 SDR Output Clocking

The ADC3660 provides a SDR output clocking option which is enabled using the SPI interface. By default the data is output on rising and falling edge of DCLK. In SDR clocking mode, DCLKIN has to be twice as fast as the default DCLKIN so that the output data are clocked out only on DCLK rising edge. This SDR clock option is available in all output modes including decimation.

Internally DCLKIN is divided by 2 for data processing and this operation can add 1 extra clock cycle latency to the ADC latency.

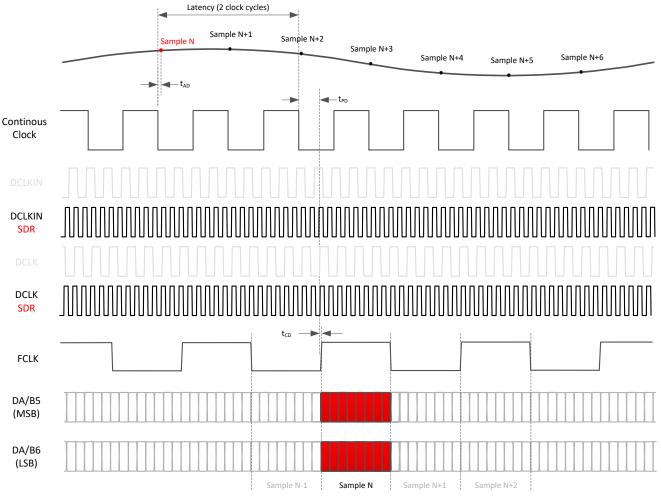


Figure 8-36. SDR Output Clocking

#### 8.3.5.2 Output Data Format

The output data can be configured to two's complement (default) or offset binary formatting using SPI register writes (register 0x8F and 0x92). Table 8-6 provides an overview for minimum and maximum output codes for the two formatting options. The actual output resolution is set by the output bit mapper.

	٦	ſwo's Comple	ement (defaul	t)	Offset Binary				
<b>RESOLUTION (BIT)</b>			ESOLUTION (BIT) 14 16 18 20		14	16	18	20	
V <sub>IN,MAX</sub>			0x1FFFF	0x7FFFF	0x3FFF	0xFFFF	0x3FFFF	0xFFFFF	
0			0x00000		0x2000	0x8000	0x20000	0x80000	
V <sub>IN.MIN</sub>	0x2000	0x2000 0x8000		0x80000	0x0	000	0x00	0000	

Table 8-6. Overview of minimum and maximum output codes vs output resolution for different formatting

#### 8.3.5.3 Output Formatter

The digital output interface utilizes a flexible output bit mapper as shown in Figure 8-37. The bit mapper takes the 16-bit output directly from the ADC or from digital filter block and reformats it to a resolution of 14,16,18 or 20-bit. The output serialization factor gets adjusted accordingly for 2-, 1- and 1/2-wire interface mode. The maximum output data rate can not be exceeded independently of output resolution and serialization factor.

#### Note

After power up the bit mapper output defaults to 18-bit and manually has to be programmed to 16-bit. See Section 8.3.5.5 for instructions.

For 14-bit the LSBs simply get truncated during the reformatting. With 18 and 20-bit output, bypass or decimation mode has 0s for the two LSBs while only the digital averaging mode utilizes the full 20-bit output.

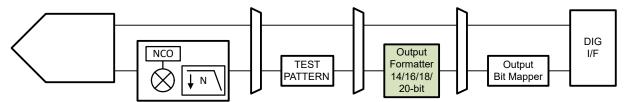


Figure 8-37. Interface output bit mapper

Table 8-7 provides an overview for the resulting serialization factor depending on output resolution and output modes. Note that the DCLKIN frequency needs to be adjusted accordingly as well. Changing the output resolution to 18-bit, 2-wire mode for example would result in DCLKIN =  $F_s * 4.5$  instead of \* 4.

Table 8-7. Serialization factor vs output resolution for different out	put modes
--	-----------

OUTPUT RESOLUTION	Interface	SERIALIZATION	FCLK	DCLKIN	DCLK	DA/B5,6					
	2-Wire	7x	F <sub>S</sub> /2	F <sub>S</sub> * 3.5	F <sub>S</sub> * 3.5	F <sub>S</sub> * 7					
14-bit	1-Wire	14x	Fs	F <sub>S</sub> * 7	F <sub>S</sub> * 7	F <sub>S</sub> * 14					
	1/2-Wire	28x	Fs	F <sub>S</sub> * 14	F <sub>S</sub> * 14	F <sub>S</sub> * 28					
	2-Wire	8x	F <sub>S</sub> /2	F <sub>S</sub> * 4	F <sub>S</sub> * 4	F <sub>S</sub> * 8					
16-bit	1-Wire	16x	Fs	F <sub>S</sub> * 8	F <sub>S</sub> * 8	F <sub>S</sub> * 16					
	1/2-Wire	32x	Fs	F <sub>S</sub> * 16	F <sub>S</sub> * 16	F <sub>S</sub> * 32					
	2-Wire	9x	F <sub>S</sub> /2	F <sub>S</sub> * 4.5	F <sub>S</sub> * 4.5	F <sub>S</sub> * 9					
18-bit (default)	1-Wire	18x	Fs	F <sub>S</sub> * 9	F <sub>S</sub> * 9	F <sub>S</sub> * 18					
	1/2-Wire	36x	Fs	F <sub>S</sub> * 18	F <sub>S</sub> * 18	F <sub>S</sub> * 36					
	2-Wire	10x	F <sub>S</sub> /2	F <sub>S</sub> * 5	F <sub>S</sub> * 5	F <sub>S</sub> * 10					
20-bit	1-Wire	20x	Fs	F <sub>S</sub> * 10	F <sub>S</sub> * 10	F <sub>S</sub> * 20					
-	1/2-Wire	40x	Fs	F <sub>S</sub> * 20	F <sub>S</sub> * 20	F <sub>S</sub> * 40					

The programming sequence to change the output interface and/or resolution from default settings is shown in Section 8.3.5.5.



#### 8.3.5.4 Output Bit Mapper

The output bit mapper allows to change the output bit order for any selected interface mode.

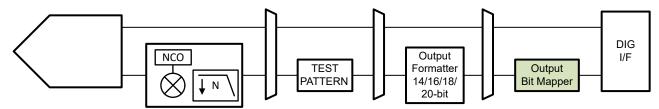


Figure 8-38. Output Bit Mapper

It is a two step process to change the output bit mapping and assemble the output data bus:

- 1. Both channel A and B can have up to 20-bit output. Each output bit of either channel has a unique identifier bit as shown in the Table 8-8. The MSB starts with bit D19 depending on output resolution chosen the LSB would be D6 (14-bit) to D0 (20-bit). The 'previous sample' is only needed in 2-w mode.
- 2. The bit mapper is then used to assemble the output sample. The following sections detail how to remap the serial output format.

 Table 8-8. Unique identifier of each data bit

Bit		nel A	Channel B				
	Previous sample (2w only)	Current sample	Previous sample (2w only)	Current sample			
D19 (MSB)	0x2D	0x6D	0x29	0x69			
D18	0x2C	0x6C	0x28	0x68			
D17	0x27	0x67	0x23	0x63			
D16	0x26	0x66	0x22	0x62			
D15	0x25	0x65	0x21	0x61			
D14	0x24	0x64	0x20	0x60			
D13	0x1F	0x5F	0x1B	0x5B			
D12	0x1E	0x5E	0x1A	0x5A			
D11	0x1D	0x5D	0x19	0x59			
D10	0x1C	0x5C	0x18	0x58			
D9	0x17	0x57	0x13	0x53			
D8	0x16	0x56	0x12	0x52			
D7	0x15	0x55	0x11	0x51			
D6	0x14	0x54	0x10	0x50			
D5	0x0F	0x4F	0x0B	0x4B			
D4	0x0E	0x4E	0x0A	0x4A			
D3	0x0D	0x4D	0x09	0x49			
D2	0x0C	0x4C	0x08	0x48			
D1	0x07	0x47	0x03	0x43			
D0 (LSB)	0x06	0x46	0x02	0x42			

In the serial output mode, a data bit (with unique identifier) needs to be assigned to each location within the serial output stream. There are a total of 40 addresses available per channel. Channel A spans from address 0x39 to 0x60 and channel B from address 0x61 to 0x88. When using complex decimation, the output bit mapper is applied to both the "I" and the "Q" sample.

**2-wire mode**: in this mode both the current and the previous sample have to be used in the address space as shown in Figure 8-39. Note: there are unused addresses between samples for resolution less than 20-bit (grey back ground), which can be skipped if not used.

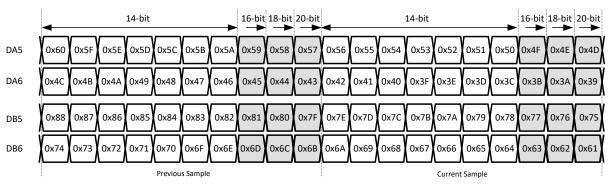


Figure 8-39. 2-wire output bit mapper

In the following example (Figure 8-40), the 16-bit 2-wire serial output is reordered to where lane DA5/DB5 carries the 8 MSB and lane DA6/DB6 carries 8 LSBs.

	Previous Sample								Current Sample							
DA5	D19 <sub>A</sub>	D18 <sub>A</sub>	D17 <sub>A</sub>	D16 <sub>A</sub>	D15 <sub>A</sub>	D14 <sub>A</sub>	D13 <sub>A</sub>	D12 <sub>A</sub>	D19 <sub>A</sub>	D18 <sub>A</sub>	D17 <sub>A</sub>	D16 <sub>A</sub>	D15 <sub>A</sub>	D14 <sub>A</sub>	D13 <sub>A</sub>	D12 <sub>A</sub>
	(0x60	(0x5F	(0x5E	(0x5D	(0x5C	(0x5B	(0x5A	(0x59	(0x56	(0x55	(0x54	(0x53	(0x52	(0x51	(0x50	(0x4F
	0x2D)	0x2C)	0x27)	0x26)	0x25)	0x24)	0x1F)	0x1E)	0x6D)	0x6C)	0x67)	0x66)	0x65)	0x64)	0x5F)	0x5E)
DA6	D11 <sub>A</sub>	D10 <sub>A</sub>	D9 <sub>A</sub>	D8 <sub>A</sub>	D7 <sub>A</sub>	D6 <sub>A</sub>	D5 <sub>A</sub>	D4 <sub>A</sub>	D11 <sub>A</sub>	D10 <sub>A</sub>	D9 <sub>A</sub>	D8 <sub>A</sub>	D7 <sub>A</sub>	D6 <sub>A</sub>	D5 <sub>A</sub>	D4 <sub>A</sub>
	(0x4C	(0x4B	(0x4A	(0x49	(0x48	(0x47	(0x46	(0x45	(0x42	(0x41	(0x40	(0x39	(0x38	(0x37	(0x36	(0x35
	0x1D)	0x1C)	0x17)	0x16)	0x15)	0x14)	0x0F)	0x0E)	0x5D)	0x5C)	0x57)	0x56)	0x55)	0x54)	0x4F)	0x4E)
DB5	D19 <sub>B</sub>	D18 <sub>B</sub>	D17 <sub>B</sub>	D16 <sub>B</sub>	D15 <sub>B</sub>	D14 <sub>B</sub>	D13 <sub>B</sub>	D12 <sub>B</sub>	D19 <sub>B</sub>	D18 <sub>B</sub>	D17 <sub>B</sub>	D16 <sub>B</sub>	D15 <sub>B</sub>	D14 <sub>B</sub>	D13 <sub>B</sub>	D12 <sub>B</sub>
	(0x88	(0x87	(0x86	(0x85	(0x84	(0x83	(0x82	(0x81	(0x7E	(0x7D	(0x7C	(0x7B	(0x7A	(0x79	(0x78	(0x77
	0x29)	0x28)	0x23)	0x22)	0x21)	0x20)	0x1B)	0x1A)	0x69)	0x68)	0x63)	0x62)	0x61)	0x60)	0x5B)	0x5A)
DB6	D11 <sub>B</sub>	D10 <sub>B</sub>	D9 <sub>B</sub>	D8 <sub>B</sub>	D7 <sub>B</sub>	D6 <sub>B</sub>	D5 <sub>B</sub>	D4 <sub>B</sub>	D11 <sub>B</sub>	D10 <sub>B</sub>	D9 <sub>B</sub>	D8 <sub>B</sub>	D7 <sub>B</sub>	D6 <sub>B</sub>	D5 <sub>B</sub>	D4 <sub>B</sub>
	(0x74	(0x73	(0x72	(0x71	(0x70	(0x6F	(0x6E	(0x6D	(0x6A	(0x69	(0x68	(0x67	(0x66	(0x65	(0x64	(0x63
	0x19)	0x18)	0x13)	0x12)	0x11)	0x10)	0x0B)	0x0A)	0x59)	0x58)	0x53)	0x52)	0x51)	0x50)	0x4B)	0x4A)

Figure 8-40. Example: 2-wire output mapping

**1-wire mode**: Only the 'current' sample needs to programmed in the address space. If desired, it can be duplicated on DA5/DB5 as well (using addresses shown in Figure 8-41 in order to have a redundant output. Lane DA5/DB5 needs to be powered up in that case.

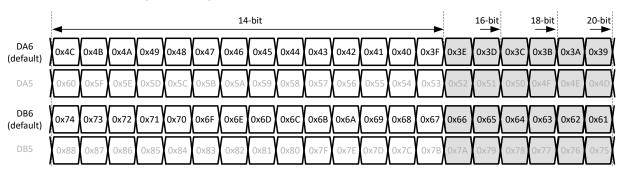
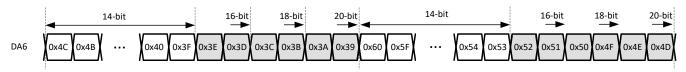
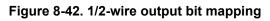


Figure 8-41. 1-wire output bit mapping

 $\frac{1}{2}$ -wire mode: The output is only on lane DA6 and the sample order is programmed into the 40 addresses of chA (from 0x39 to 0x60). It covers 2 samples (one for chA, one for chB) as shown in Figure 8-42.







#### 8.3.5.5 Output Interface/Mode Configuration

The following sequence summarizes all the relevant registers for changing the output interface and/or enabling the decimation filter. Steps 1 and 2 must come first since the E-Fuse load reset the SPI writes, the remaining steps can come in any order.

STEP	FEATURE	ADDRESS								
			Select the output interf	ace bit mapping depen	ding on resolution and o	output interface.				
		007	Output R	esolution	2-wire	1-wire	1/2-wire			
1		0x07	14-bit,	18-bit	0x2B	0x6C	0x8D			
			16-bit,	20-bit	0x4B	UXOC	0800			
2	-	0x13		.oad the output interface bit mapping using the E-fuse loader (0x13, D0). Program register 0x13 to 0x01, wait ~ ms so that bit mapping is loaded properly followed by 0x13 0x00						
3		0x0A/B/C	When changing the ou	When changing the output interface bit mapper (0x07), the CMOS output buffer register has to be configured						
4		0x18	When changing the ou	tput interface bit mappe	er (0x07), the DCLKIN E	N bit (D4) has to be set	again.			
			Configure the FCLK frequency based on bypass/decimation and number of lanes used.							
			Bypass/Dec	SCMOS	FCLK SRC (D7)	FCLK DIV (D4)	TOG FCLK (D0)			
				2-wire	0	1	0			
5		0x19	Bypass/ Real Decimation	1-wire	0	0	0			
				1/2-wire	0	0	0			
				2-wire	1	0	0			
	Output		Complex Decimation	1-wire	1	0	0			
	Interface			1/2-wire	0	0	1			
6		0x1B	Select the output interf	ace resolution using the						
7		0x1F	When changing the ou set again.	tput interface bit mappe	N bit (D6) and DCLK O	B EN (D4) have to be				
			Select the FCLK pattern for decimation for proper duty cycle output of the frame clock.							
		0x20 0x21 0x22		Output Resolution	2-wire	1-wire	1/2-wire			
				14-bit		0xFE000				
			Real Decimation	16-bit	use default	0xFF000	use default			
8				18-bit		0xFF800	use deladit			
0				20-bit		0xFFC00				
				14-bit	use delault	0xFFFF				
			Complex Decimation	16-bit	-		0xFFFFF			
			Complex Decimation	18-bit			0XIIIII			
				20-bit						
9		0x390x60 0x610x88	Change output bit map	pping for chA and chB if	desired. This works als	o with the default interfa	ace selection.			
10		0x24	Enable the decimation	filter						
11		0x25	Configure the decimati	ion filter						
12		0x2A/B/C/D 0x31/2/3/4	Program the NCO freq	uency for complex deci	mation (can be skipped	for real decimation)				
	Decimation		Configure the complex	output data stream (se	t both bits to 0 for real d	lecimation)				
	Decimation Filter		SCMOS			OP-Order (D4)	Q-Delay (D3)			
13		0x27 0x2E	2-wire			1	0			
		UNEL	1-wire			0	1			
			1/2-wire		1	1				
14	1	0x26	Set the mixer gain and							

#### Table 8-9. Configuration steps for changing interface or decimation



#### 8.3.5.5.1 Configuration Example

The following is a step by step programming example to configure the ADC3660 to complex decimation by 8 with 1-wire SCMOS and 16-bit output.

- 1. 0x07 (address) 0x6C (load bit mapper configuration for 16-bit output with 1-wire SCMOS)
- 2. 0x13 0x01, wait 1 ms, 0x13 0x00 (load e-fuse)
- 3. 0x0A 0xFF, 0x0B 0xEE, 0x0C 0xFD (configure CMOS output buffer)
- 4. 0x18 0x10 (DCLKIN EN)
- 5. 0x19 0x82 (configure FCLK)
- 6. 0x1B 0x08 (select 16-bit output resolution)
- 7. 0x1F 0x50 (DCLKIN EN and DCLK OB EN)
- 8. 0x20 0xFF, 0x21 0xFF, 0x22 0x0F (configure FCLK pattern)
- 9. 0x24 0x06 (enable decimation filter)
- 10. 0x25 0x30 (configure complex decimation by 8)
- 11. 0x2A/B/C/D and 0x31/32/33/34 (program NCO frequency)
- 12. 0x27/0x2E 0x08 (configure Q-delay register bit)
- 13. 0x26 0xAA, 0x26 0x88 (set digital mixer gain to 6-dB and toggle the mixer update)

#### 8.3.6 Test Pattern

In order to enable in-circuit testing of the digital interface, the following test patterns are supported and enabled via SPI register writes (0x14/0x15/0x16). The test pattern generator is located after the decimation filter as shown in Figure 8-43. In decimation mode (real and complex), the test patterns replace the output data from the DDC - however channel A controls the test patterns for both channels.

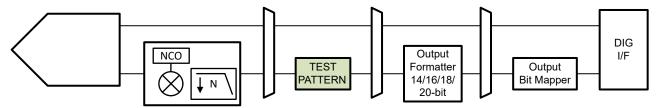


Figure 8-43. Test Pattern Generator

- RAMP Pattern: The step size needs to be configured in the CUSTOM PAT register according to the native resolution of the ADC. When selecting a higher output resolution then the additional LSBs will still be 0 in RAMP pattern mode.
  - 00001: 18-bit output resolution
  - 00100: 16-bit output resolution
  - 10000: 14-bit output resolution
- · Custom Pattern: Configured in the CUSTOM PAT register



#### 8.4 Device Functional Modes

#### 8.4.1 Normal Operation

In normal operating mode, the ADC full-scale input gets converted to a digital output with 16-bit resolution.

#### 8.4.2 Power Down Options

A global power down mode can be enabled via SPI as well as using the power down pin (PDN/SYNC). There is an internal pull-down  $21k\Omega$  resistor on the PDN/SYNC input pin and the pin is active high - so the pin needs to be pulled high externally to enter global power down mode.

The SPI register map provides the capability to enable/disable individual blocks directly or via PDN pin mask in order to trade off power consumption vs wake up time as shown in Table 8-10.

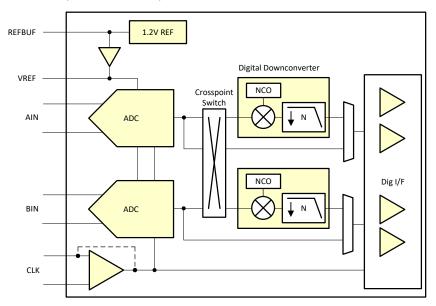


Figure 8-44. Power Down Configurations

	Table 8-10.	Overview	of Power	Down	Options
--	-------------	----------	----------	------	---------

Function/ Register	PDN via SPI	Mask for Global PDN	Feature - Default	Power Impact	Wake-up time	Comment	
ADC	Yes	-	Enabled			Both ADC channels are included in Global PDN automatically	
Reference gain amplifier	Yes		Enabled	~ 0.4 mA	~3 us	Should only be powered down in power down state.	
Internal 1.2V reference		Yes	External ref	~ 1-3.5 mA	~3 ms	Internal/external reference selection is available through SPI and REFBUF pin.	
Clock buffer	Yes		Differential clock	~ 1 mA	n/a	Single ended clock input saves ~ 1mA compared to differential. Some programmability is available through the REFBUF pin.	
Output interface drivers	Yes	-	Enabled	varies	n/a	Depending on output interface mode, unused output drivers can be powered down for maximum power savings	
Decimation filter	Yes	-	Disabled	see electrical table	n/a		



#### 8.4.3 Digital Channel Averaging

The ADC3660 includes a digital channel averaging feature which enables improvement of the ADC dynamic range (see Figure 8-45). The same input signal is given to both ADC inputs externally and the output of the two ADCs is averaged internally. By averaging, uncorrelated noise (e.g. ADC thermal noise) improves 3-dB while correlated noise (e.g. jitter in the clock path, reference noise) is unaffected. Therefore the averaging gives close to 3-dB improvement at low input frequencies but less at high input frequencies where clock jitter dominates the SNR.

The output from the digital averaging block is given out on the digital outputs of channel A or alternatively can be routed to the digital decimation filters using the digital mux.

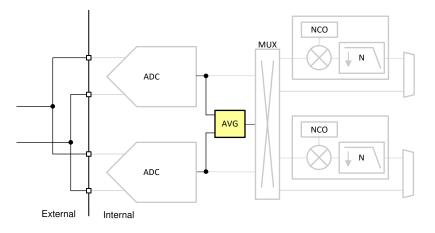


Figure 8-45. Digital Channel Averaging Diagram



#### 8.5 Programming

The device is primarily configured and controlled using the serial programming interface (SPI) however it can operate in a default configuration without requiring the SPI interface. Furthermore the power down function as well as internal/external reference configuration is possible via pin control (PDN/SYNC and REFBUF pin).

#### Note

The power down command (via PIN or SPI) only goes in effect with the ADC sampling clock present.

After initial power up, the default operating configuration for each device is shown in Table 8-11.

#### Table 8-11. Default device configuration after power up

Table 0-11. Detault device configuration after power up									
FEATURE	ADC3660								
Signal Input	Differential								
Auto-zero	Disabled								
Clock Input	Differential								
Reference	External								
Decimation	DDC bypass								
Interface	2-wire								
Output Format	2s complement								

#### 8.5.1 Configuration using PINs only

The ADC voltage reference can be selected using the REFBUF pin. Even though there is an internal 100 k $\Omega$  pull-up resistor to AVDD, the REFBUF pin should be set to a voltage externally and not left floating.

REFBUF VOLTAGE	VOLTAGE REFERENCE OPTION	CLOCKING OPTION		
> 1.7 V (Default)	External reference	Differential clock input		
1.2 V (1.15-1.25V)	External 1.2V input on REFBUF pin using internal gain buffer	Differential clock input		
0.5 - 0.7V	Internal reference	Differential clock input		
< 0.1V	Internal reference	Single ended clock input		

#### Table 8-12. REFBUF voltage levels control voltage reference selection

#### 8.5.2 Configuration using the SPI interface

The device has a set of internal registers that can be accessed by the serial interface formed by the SEN (serial interface enable), SCLK (serial interface clock) and SDIO (serial interface data input/output) pins. Serially shifting bits into the device is enabled when SEN is low. Serial data input are latched at every SCLK rising edge when SEN is active (low). The serial data are loaded into the register at every 24th SCLK rising edge when SEN is low. When the word length exceeds a multiple of 24 bits, the excess bits are ignored. Data can be loaded in multiples of 24-bit words within a single active SEN pulse. The interface can function with SCLK frequencies from 12 MHz down to very low speeds (of a few hertz) and also with a non-50% SCLK duty cycle.

#### 8.5.2.1 Register Write

The internal registers can be programmed following these steps:

- 1. Drive the SEN pin low
- 2. Set the R/W bit to 0 (bit A15 of the 16-bit address) and bits A[14:12] in address field to 0.
- 3. Initiate a serial interface cycle by specifying the address of the register (A[11:0]) whose content is written and
- 4. Write the 8-bit data that are latched in on the SCLK rising edges

Figure 8-46 shows the timing requirements for the serial register write operation.



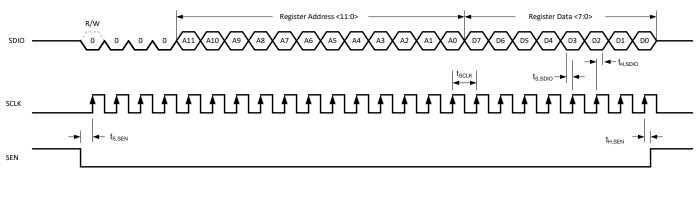


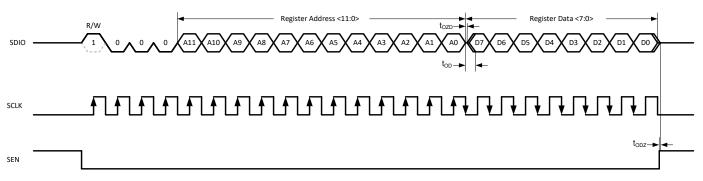
Figure 8-46. Serial Register Write Timing Diagram

#### 8.5.2.2 Register Read

RESET

The device includes a mode where the contents of the internal registers can be read back using the SDIO pin. This readback mode can be useful as a diagnostic check to verify the serial interface communication between the external controller and the ADC. The procedure to read the contents of the serial registers is as follows:

- 1. Drive the SEN pin low
- 2. Set the R/W bit (A15) to 1. This setting disables any further writes to the registers. Set A[14:12] in address field to 0.
- 3. Initiate a serial interface cycle specifying the address of the register (A[11:0]) whose content must be read
- 4. The device outputs the contents (D[7:0]) of the selected register on the SDIO pin
- 5. The external controller can latch the contents at the SCLK falling edge



#### Figure 8-47. Serial Register Read Timing Diagram



### 8.6 Register Maps

REGISTER ADDRESSDFD6D5D4D3D2D1D00x000000000000000x070PIEMAPPER*00PIENPDNALPIENAPPER*0PIDNAPDNAPDNAPDNAL0x08000PDN CLKBUPPPN REFAMP0PDNAPDNAPDNAPDNAL0x000000PDN CLKBUPPSNS <th></th> <th colspan="11">Table 8-13. Register Map Summary</th>		Table 8-13. Register Map Summary										
0x00         0         0         0         0         0         0         0         RESET           0x07         OP IF MAPPER         0         OP IF EN         OP IF SEL         OP IF SEL           0x08         0         0         PDN CLKBUF         PPN REFAMP         0         PDN A         PDN B         POM           0x08         0         0         PDN CLKBUF         PPN REFAMP         0         PDN A         PDN B         GLOBAL           0x08         O         0         OSOB DIS [7:0]         CMOSOB DIS [7:0]         Set					REGIST	ER DATA						
0x07OP IF MAPPER0OP IF APUN PIN APDN BPDN QLOBAL QLOBAL0x0800PDN CLKBUFREFAMP0PDN APDN BQLOBAL QLOBAL0x0ACMOS OB DIS [7:0]0x0ACMOS OB DIS [7:3]0x0A0000MASK CLKBUFMASK REFAMPMASK BG DIS00x0D0000MASK CLKBUFMASK REFAMPDIS00x0ESYNC PIN 	A[11:0]	D7	D6	D5	D4	D3	D2	D1	D0			
0x08         0         0         PDN A         PDN B         PDN GLOBAL GLOBAL           0x00	0x00	0	0	0	0	0	0	0	RESET			
0x0000PDN CLRBUPREFAMP0PDN APDN BGLOBAL0x00CMOS OB DIS [15:8]CMOS OB DIS [15:8]CMOS OB DIS [15:8]CMOS OB DIS [15:8]CMOS OB DIS [23:16]0x000000MASK CLRBUFMASK REFAMPMASK BC DIS00x00000CLRBUFMASK BC REFAMPDIS0AZ EN0x0100SE ASE B0DLL PON0AZ EN0x13000000E-FUSE LD0x14	0x07		OP IF MAPPER		0	OP IF EN		OP IF SEL				
0x0B         USON DIS [15.8]           0x0C         USON DIS [15.8]           0x0D         0         0         0         0         0         MASK CLKBUF         MASK REFAMP         MASK DIS         0         0           0x0E         SYNC PIN EN         SPI SYNC         SPI SYNC PIN EN         SPI SYNC SPI SYNC PIN         0         REF CTRL         REF X         SE CLK EN           0x11         0         0         SE A         SE B         0         DLL PDN         0         AZ EN           0x13         0         0         SE A         SE B         0         DLL PDN         0         AZ EN           0x14         0         0         SE A         SE B         0         DLL PDN         0         AZ EN           0x15         USTON PAT [15.8]         CUSTOM PAT [15.8]         CUSTOM PAT [17.0]         O         0	0x08	0	0	PDN CLKBUF		0	PDN A	PDN B				
0x0C         0         0         0         MASK CLKBW         MASK REFAMP         MASK BG DIS         0           0x0E         SYNC PIN EN         SPI SYNC         SPI SYNC EN         0         REF CTRL         REF SEL         SE CLK EN           0x11         0         0         SE         SE         0         DLL PDN         0         AZ EN           0x13         0         0         0         0         0         0         0         EFUSELD           0x14           CUSTOM PAT [17:8]          CUSTOM PAT [17:16]           0x15           TEST PAT B         CUSTOM PAT [17:16]         CUSTOM PAT [17:16]           0x18         0         0         0         DCLKIN N         0         0         0         0           0x18         MAPPER EN         20B EN         BIT MAPPER RES         0         0         0         0         0           0x11         DCLKIN EN         0         DLK OB EN         2X DCLK         0         0         0         0           0x14         DCLKIN EN         DCLKIN EN         V         CLK PAT [19:16]         0         0         0         0         0	0x0A				CMOS OE	3 DIS [7:0]						
0x0D0000MASK CLKBUFMASK REFAMPMASK BG DIS00x0ESYIC PIN ENSPI SYNCSPI SYNC PI0REF CTRLREF CTRLSE CLK EN0x1100SE ASE B0DL LPDN0AZ EN0x130000000EFUSE LD0x14	0x0B				CMOS OB	DIS [15:8]						
0x0D000CLKBUFREF AMPDIS00x0ESYNC PIN ENSPI SYNC EN0REF CTRLREF CTRLSE CLK EN0x1100SE ASE B0DLL PDN0AZ EN0x130000O0DLL PDN0E-FUSE LD0x140000DTT (7)VSE ASE B00DE-FUSE LD0x15000DCUSTOM PAT (7:0)SE ASE A <td>0x0C</td> <td></td> <td></td> <td></td> <td>CMOS OB</td> <td>DIS [23:16]</td> <td></td> <td></td> <td></td>	0x0C				CMOS OB	DIS [23:16]						
DADE ENENSPI SYNCSPI SYNC ENUREF CIRCREF CIRCREF CIRCSE CLR EN0x1100SE ASE B0DLL PDN0AZ EN0x13000000EFUS ELD0x14CUSTOM PAT [7:0]EFUS ELD0x16TEST PAT BCUSTOM PAT [15:8]CUSTOM PAT [17:16]0x18000FCLK DIV0000x18000FCLK DIV0000x18MAPPER RE00FCLK DIV0000x18MAPPER RE206 ENSE CLK DIV00000x18MAPPER REN206 ENCMOS UFCLK DIV00000x1400CLKIN EN0000000x1400CLKIN ENZZ CLK00000x24000OCLKIN ENDIG BYPDDC ENMIX FPASE0x24000OOMIX FPASEMIX FPASEMIX FPASEFS/4 MIX AMIX FEA LOUTMIX FEA LOUTMIX FEA LOUT000x26DC MUX ENDE CLMATIONPC ALD	0x0D	0	0	0	0				0			
0x13000000E-FUSE LD0x14	0x0E		SPI SYNC	SPI SYNC EN	0	REF CTRL	REF	SEL	SE CLK EN			
0x14         CUSTOM PAT [7:0]           0x15         CUSTOM PAT [15:8]           0x16         TEST PAT B         CUSTOM PAT [17:16]           0x18         0	0x11	0	0	SE A	SE B	0	DLL PDN	0	AZ EN			
Ox15USTOM PAT [15:8]0x16TEST PAT BCUSTOM PAT [17:16]0x18000DCLKIN EN0000x19FCLK SRC00FCLK DIV00FCLK ENTOG FCLK0x18MAPPER RE208 ENBIT MAPPER RES000000x11E00CMOS DCLK DEL0000000x11ELOW DR ENDCLKIN EN0DCLK OB EN2X DCLK000000x20DCTFCLK PAT [15:8]TCLK PAT [19:16]TCLK PAT [19:16]00 <td>0x13</td> <td>0</td> <td>0</td> <td>0</td> <td>0</td> <td>0</td> <td>0</td> <td>0</td> <td>E-FUSE LD</td>	0x13	0	0	0	0	0	0	0	E-FUSE LD			
0x16TEST PAT BCUSTOM PAT [17:16]0x18000DCLKIN EN0000x19FCLK SRC00FCLK DIV00FCLK ENTOG FCLK0x18MAPPER N20B ENBIT MAPPER RES000000x11200CMOS DCLK DEL000000x140DCLKIN EN0DCLK OB EN2X DCLK00000x17LOW DR ENDCLKIN EN0DCLK OB EN2X DCLK00000x20FCLK PAT [15:8]DCC MUXDIG BYPDDC EN0000x21FCLK PAT [15:16]DC EN00000x22000OCFCLK PAT [15:16]0000x2400CH AVG ENDDC MUXDIG BYPDDC EN00x25DDC MUX ENDECIMATIONREAL OUT00MIX PHASE0x26MIXGAN AMIX RES AFS/4 MIX AMIX RES BFS/4 MIX B0x27000OP ORDER AQ-DEL AFS/4 MIX PH B000x28NCO A [15:8]NCO A [15:8]000x27000OP ORDER BQ-DEL BFS/4 MIX PH B000x28NCO A [15:8]000x31	0x14	CUSTOM PAT [7:0]										
0x18         0         0         0         CLK IN         0         0         0         0           0x19         FCLK SRC         0         0         FCLK DIV         0         0         FCLK EN         TOG FCLK           0x18         MAPPER EN         20B EN         BIT MAPPER RES         0         0         0         0           0x1E         0         0         CMOS DLK DEL         0         0         0         0           0x1F         LOW DR EN         DCLKIN EN         0         DCLK OB EN         2X DCLK         0         0         0           0x20          TECLK PAT [T:0]         0         0         0         0         0           0x21           FCLK PAT [T:0]         DIG BYP         DDC EN         0           0x22         0         0         CH AVG EN         DDC MUX         DIG BYP         DDC EN         0           0x24         0         0         CH AVG EN         DDC MUX         DIG BYP         DDC EN         0           0x25         DDC MUX EN         DECIMATION         REAL OUT         0         0         0           0x26         MIX GAN A         MIX	0x15	CUSTOM PAT [15:8]										
0x19FCLK SRC00FCLK DIV00FCLK ENTOG FCLK0x18MAPPER EN20B ENBIT MAPPER RES00000x1F00CMOS DEK DEL00000x1FLOW DR ENDCLKIN EN0DCLK OB EN2X DCLK0000x20 $$	0x16		TEST PAT B			TEST PAT A		CUSTOM PAT [17:16]				
0x1BMAPPER EN20B ENBIT MAPPER RES0000x1E00CMOS DELK DEL00000x1FLOW DR ENDELKIN EN0DELK OB EN2X DELK0000x20 $V = V = V = V = V = V = V = V = V = V =$	0x18	0	0	0	DCLKIN EN	0	0	0	0			
0x1E00CMOS DCLK DEL00000x1FLOW DR ENDCLKIN EN0DCLK OB EN2X DCLK0000x20FCLK PAT [7:0] </td <td>0x19</td> <td>FCLK SRC</td> <td>0</td> <td>0</td> <td>FCLK DIV</td> <td>0</td> <td>0</td> <td>FCLK EN</td> <td>TOG FCLK</td>	0x19	FCLK SRC	0	0	FCLK DIV	0	0	FCLK EN	TOG FCLK			
0x1FLOW DR ENDCLKIN EN0DCLK OB EN2X DCLK0000x20FCLK PAT [7:0] <t< td=""><td>0x1B</td><td>MAPPER EN</td><td>20B EN</td><td>В</td><td>IT MAPPER RE</td><td>S</td><td>0</td><td>0</td><td>0</td></t<>	0x1B	MAPPER EN	20B EN	В	IT MAPPER RE	S	0	0	0			
0x20         FCLK PAT [7:0]           0x21         FCLK PAT [15:8]           0x22         0         0         0         FCLK PAT [15:8]           0x24         0         0         0         FCLK PAT [15:8]           0x24         0         0         CH AVG EN         DDC MUX         DIG BYP         DDC EN         0           0x25         DDC MUX EN         DECIMATION         REAL OUT         0         0         MIX RES B         FS/4 MIX B           0x26         MIX GAIN A         MIX RES A         FS/4 MIX A         MIX GAIN B         MIX RES B         FS/4 MIX B           0x27         0         0         0         OP ORDER A         Q-DEL A         FS/4 MIX PH A         0         0           0x28           VICO A [7:0]         NCO A [31:24]         0         0           0x20           NCO A [31:24]         0         0         0           0x31           VICO B [7:0]         NCO B [23:16]         VICO S [31:24]         VICO S [31:24]         VICO S [31:24]           0x33            OUTPUT BIT MAPPER CHA         VICO S [31:24]         VICO S [31:24] </td <td>0x1E</td> <td>0</td> <td>0</td> <td>CMOS D</td> <td>CLK DEL</td> <td>0</td> <td>0</td> <td>0</td> <td>0</td>	0x1E	0	0	CMOS D	CLK DEL	0	0	0	0			
0x21         FCLK PAT [15:8]           0x22         0         0         0         0         FCLK PAT [19:16]           0x24         0         0         CH AVG EN         DDC MUX         DIG BYP         DDC EN         0           0x25         DDC MUX EN         DECIMATION         REAL OUT         0         0         MIX RES B         FS/4 MIX B           0x26         MIX GAIN A         MIX RES A         FS/4 MIX A         MIX RES B         FS/4 MIX B         MIX RES B         FS/4 MIX B           0x27         0         0         0         OP ORDER A         Q-DEL A         FS/4 MIX PH A         0         0           0x28         C         V         NCO A [23:16]         V         V         V         O           0x20         0         0         0         OP ORDER B         Q-DEL B         FS/4 MIX PH B         0         0           0x31         0         0         OP ORDER B         Q-DEL B         FS/4 MIX PH B         0         0           0x33         0         V         NCO B [7:0]         V         V         V         V           0x34         V         V         V         VCO B [31:24]         V         <	0x1F	LOW DR EN	DCLKIN EN	0	DCLK OB EN	2X DCLK	0	0	0			
0x22         0         0         0         FCLK PAT [19:16]           0x24         0         0         CH AVG EN         DDC MUX         DIG BYP         DDC EN         0           0x25         DDC MUX EN $OCCMIX EN$ DECIMATION         REAL OUT         0         0         MIX PHASE           0x26         MIX GIN A         MIX RES A         FS/4 MIX A         MIX FB         MIX RES B         FS/4 MIX B         MIX RES B         FS/4 MIX B         0	0x20				FCLK P	AT [7:0]						
0x24         0         0         CH AVG EN         DDC MUX         DIG BYP         DDC EN         0           0x25         DDC MUX EN $\_$ $\_$ REAL OUT         0         0         MIX PHASE           0x26         MIX GEN         MIX RES A         FS/4 MIX A         MIX GEN B         MIX RES B         FS/4 MIX B           0x27         0         0         0         OP ORDER A         Q-DEL A $\frac{FS/4 MIX PH}{A}$ 0         0           0x2A $\_$ <	0x21				FCLK P/	AT [15:8]						
0x25DDC MUX ENDECIMATIONREAL OUT0MIX PHASE0x26MIX $-$ NAMIX RES AFS/4 MIX AMIX $-$ NBMIX RES BFS/4 MIX B0x27000OP ORDER AQ-DEL A $FS/4$ MIX PH A000x2A $         -$	0x22	0	0	0	0		FCLK PA	T [19:16]				
0x26MIX RES AFS/4 MIX AMIX RES BMIX RES BFS/4 MIX B0x270000P ORDER AQ-DEL A $FS/4$ MIX PH A000x2A $$	0x24	0	0	CH AVG EN	DDC	MUX	DIG BYP	DDC EN	0			
0x27 $0$ $0$ $0$ $0$ $0$ $0$ $0$ $0$ $0x2A$ $$	0x25	DDC MUX EN		DECIMATION		REAL OUT	0	0	MIX PHASE			
0x27         0         0         0P ORDER A         Q-DEL A         A         0         0           0x2A	0x26	MIX G	AIN A	MIX RES A	FS/4 MIX A	MIX G	SAIN B	MIX RES B	FS/4 MIX B			
0x2B       Image: NCO A [15:8]         0x2C       NCO A [23:16]         0x2D       Image: NCO A [31:24]         0x2E       0       0       OP ORDER B       Q-DEL B       FS/4 MIX PH B       0       0         0x31       Image: Imag	0x27	0	0	0	OP ORDER A	Q-DEL A	-	0	0			
0x2C       NCO A [23:16]         0x2D       NCO A [31:24]         0x2E       0       0       OP ORDER B       Q-DEL B       FS/4 MIX PH B       0       0         0x31       0       0       OP ORDER B       Q-DEL B       FS/4 MIX PH B       0       0         0x32       0       VICO B [7:0]       VICO B [15:8]	0x2A				NCO /	A [7:0]						
0x2D       NCO A [31:24]         0x2E       0       0       0P ORDER B       Q-DEL B       FS/4 MIX PH B       0       0         0x31	0x2B				NCO A	[15:8]						
0x2E         0         0         0P ORDER B         Q-DEL B         FS/4 MIX PH B         0         0           0x31	0x2C				NCO A	[23:16]						
0X2E         0	0x2D				NCO A	[31:24]						
0x32         NCO B [15:8]           0x33         NCO B [23:16]           0x34         NCO B [31:24]           0x390x60         OUTPUT BIT MAPPER CHA           0x610x88         OUTPUT BIT MAPPER CHB	0x2E	0	0	0	OP ORDER B	Q-DEL B		0	0			
0x33         NCO B [23:16]           0x34         NCO B [31:24]           0x390x60         OUTPUT BIT MAPPER CHA           0x610x88         OUTPUT BIT MAPPER CHB	0x31	NCO B [7:0]										
0x34         NCO B [31:24]           0x390x60         OUTPUT BIT MAPPER CHA           0x610x88         OUTPUT BIT MAPPER CHB	0x32	NCO B [15:8]										
0x390x60     OUTPUT BIT MAPPER CHA       0x610x88     OUTPUT BIT MAPPER CHB	0x33											
0x610x88 OUTPUT BIT MAPPER CHB	0x34				NCO B	[31:24]						
	0x390x60											
0x8F 0 0 0 0 0 0 FORMAT A 0	0x610x88				OUTPUT BIT	MAPPER CHB						
	0x8F	0	0	0	0	0	0	FORMAT A	0			
0x92 0 0 0 0 0 0 0 FORMAT B 0	0x92	0	0	0	0	0	0	FORMAT B	0			

#### Table 8-13. Register Map Summary



#### 8.6.1 Detailed Register Description

#### Figure 8-48. Register 0x00

7	6	5	4	3	2	1	0
0	0	0	0	0	0	0	RESET
R/W-0							

#### Table 8-14. Register 0x00 Field Descriptions

Bit	Field	Туре	Reset	Description
7-1	0	R/W	0	Must write 0
0	RESET	R/W	0	This bit resets all internal registers to the default values and self clears to 0.

#### Figure 8-49. Register 0x07

7	6	5	4	3	2	1	0
	OP IF MAPPER		0	OP IF EN		OP IF SEL	
R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0

	la	DIE 8-15. RE	Field Descriptions	
Bit	Field	Туре	Reset	Description
7-5	OP IF MAPPER	R/W	000	Output interface mapper. This register contains the proper output interface bit mapping for the different interfaces. The interface bit mapping is internally loaded from e-fuses and also requires a fuse load command to go into effect (0x13, D0). Register 0x07 along with the E-Fuse Load (0x13, D0) needs to be loaded first in the programming sequence since the E-Fuse load resets the SPI writes. After initial reset the default output interface variant is loaded automatically from fuse internally. However when reading back this register reads 000 until a value is written using SPI. 001: 2-wire, 18 and 14-bit 010: 2-wire, 20 and 16-bit 011: 1-wire 100: 0.5-wire others: not used
4	0	R/W	0	Must write 0
3	OP IF EN	R/W	0	Enables changing the default output interface mode (D2- D0).When changing the output interface mode, the registers 0x0A/0B/0C, 0x18, 0x19 and 0x1F have to written as well.
2-0	OP IF SEL	R/W	000	Selection of the output interface mode. OP IF EN (D3) needs to be enabled also. After initial reset the default output interface is loaded automatically from fuse internally. However when reading back this register reads 000 until a value is written using SPI. 011: 2-wire 100: 1-wire 101: 0.5-wire others: not used

#### Table 8-15. Register 0x07 Field Descriptions



	Figure 8-50. Register 0x08								
7	6	5	4	3	2	1	0		
0	0	PDN CLKBUF	PDN REFAMP	0	PDN A	PDN B	PDN GLOBAL		
R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0		

#### Table 8-16. Register 0x08 Field Descriptions

Bit	Field	Туре	Reset	Description
7-6	0	R/W	0	Must write 0
5	PDN CLKBUF	R/W	0	Powers down sampling clock buffer 0: Clock buffer enabled 1: Clock buffer powered down
4	PDN REFAMP	R/W	0	Powers down internal reference gain amplifier 0: REFAMP enabled 1: REFAMP powered down
3	0	R/W	0	Must write 0
2	PDN A	R/W	0	Powers down ADC channel A 0: ADC channel A enabled 1: ADC channel A powered down
1	PDN B	R/W	0	Powers down ADC channel B 0: ADC channel B enabled 1: ADC channel B powered down
0	PDN GLOBAL	R/W	0	Global power down via SPI 0: Global power disabled 1: Global power down enabled. Power down mask (register 0x0D) determines which internal blocks are powered down.

ADC3660 SBASA01B – SEPTEMBER 2020 – REVISED MARCH 2022



	Figure 8-51. Register 0x0A/B/C								
7	6	5	4	3	2	1	0		
			CMOS OB	DIS [23:0]					
R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0		

#### Table 8-17. Register 0x0A/B/C Field Descriptions

Bit	Field	Туре	Reset	Description
7:0	CMOS OB DIS [23:0]	R/W	0	These register bits power down the individual CMOS output buffers. See Table 8-18 for the actual bit to pin mapping. Unused pins can be powered down (ie set to 1) for maximum power savings. Even though unused outputs don't toggle there is still a small amount of static power (< 1mA) that can be saved by disabling the output buffers.When changing the output interface mode (0x07) these registers have to be written again. There is a separate control to enable the DCLKIN buffer in register 0x1F (D6) and 0x18 (D4). DCLK output buffer is powered down using register 0x1F (D4). 0: Output buffer enabled 1: Output buffer powered down

#### Table 8-18. Output buffer enable bit mapping vs output interface mode

	· · ·		<u> </u>		
ADDRESS (HEX)	BIT	PIN NAME	SCMOS 2-w	SCMOS 1-w	SCMOS 1/2-w
	D7	DB5	DB5	-	-
	D6/D5/D4	-	-	-	-
0x0A	D3	DCLKIN	DCLKIN	DCLKIN	DCLKIN
	D2/D1/D0	-	-	-	-
	Register	setting	0x7F	0xFF	0xFF
	D7/D6/D5	-	-	-	-
	D4	FCLK	FCLK	FCLK	FCLK
0x0B	D3/D2/D1	-	-	-	-
	D0	DB6	DB6	DB6	-
	Register	<sup>-</sup> setting	0xEE	0xEE	0xEF
	D7/D6/D5/D4/D3/D2	-	-	-	-
0x0C	D1	DA6	DA6	DA6	DA6
0,000	D0	DA5	DA5	-	-
	Register	setting	0xFC	0xFD	0xFD



Figure 8-52. Register 0x0D (PDN GLOBAL MASK)									
7	6	5	4	3	2	1	0		
0	0	0	0	MASK CLKBUF	MASK REFAMP	MASK BG DIS	0		
R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0		

#### Table 8-19. Register 0x0D Field Descriptions

Bit	Field	Туре	Reset	Description
7-4	0	R/W	0	Must write 0
3	MASK CLKBUF	R/W	0	<ul> <li>Global power down mask control for sampling clock input buffer.</li> <li>0: Clock buffer will get powered down when global power down is exercised.</li> <li>1: Clock buffer will NOT get powered down when global power down is exercised.</li> </ul>
2	MASK REFAMP	R/W	0	<ul> <li>Global power down mask control for reference amplifier.</li> <li>0: Reference amplifier will get powered down when global power down is exercised.</li> <li>1: Reference amplifier will NOT get powered down when global power down is exercised.</li> </ul>
1	MASK BG DIS	R/W	0	<ul> <li>Global power down mask control for internal 1.2V bandgap voltage reference. Setting this bit reduces power consumption in global power down mode but increases the wake up time. See the power down option overview.</li> <li>0: Internal 1.2V bandgap voltage reference will NOT get powered down when global power down is exercised.</li> <li>1: Internal 1.2V bandgap voltage reference will get powered down when global power down is exercised.</li> </ul>
0	0	R/W	0	Must write 0

ADC3660 SBASA01B – SEPTEMBER 2020 – REVISED MARCH 2022



	Figure 8-53. Register 0x0E							
7	6	5	4	3	2	1	0	
SYNC PIN EN	SPI SYNC	SPI SYNC EN	0	REF CTL	REF	SEL	SE CLK EN	
R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	

#### Table 8-20. Register 0x0E Field Descriptions

Bit	Field	Туре	Reset	Description
7	SYNC PIN EN	R/W	0	<ul> <li>This bit controls the functionality of the SYNC/PDN pin.</li> <li>0: SYNC/PDN pin exercises global power down mode when pin is pulled high.</li> <li>1: SYNC/PDN pin issues the SYNC command when pin is pulled high.</li> </ul>
6	SPI SYNC	R/W	0	Toggling this bit issues the SYNC command using the SPI register write. SYNC using SPI must be enabled as well (D5). This bit doesn't self reset to 0. 0: Normal operation 1: SYNC command issued.
5	SPI SYNC EN	R/W	0	<ul><li>This bit enables synchronization using SPI instead of the SYNC/PDN pin.</li><li>0: Synchronization using SPI register bit disabled.</li><li>1: Synchronization using SPI register bit enabled.</li></ul>
4	0	R/W	0	Must write 0
3	REF CTL	R/W	0	This bit determines if the REFBUF pin controls the voltage reference selection or the SPI register (D2-D1). 0: The REFBUF pin selects the voltage reference option. 1: Voltage reference is selected using SPI (D2-D1) and single ended clock using D0.
2-1	REF SEL	R/W	00	Selects of the voltage reference option. REF CTRL (D3) must be set to 1. 00: Internal reference 01: External voltage reference (1.2V) using internal reference buffer (REFBUF) 10: External voltage reference 11: not used
0	SE CLK EN	R/W	0	Selects single ended clock input and powers down the differential sampling clock input buffer. REF CRTL (D3) must be set to 1. 0: Differential clock input 1: Single ended clock input



	Figure 8-54. Register 0x11									
7	6	5	4	3	2	1	0			
0	0	SE A	SE B	0	DLL PDN	0	AZ EN			
R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0			

#### Table 8-21. Register 0x11 Field Descriptions

Bit	Field	Туре	Reset	Description
7-6	0	R/W	0	Must write 0
5	SE A	R/W	0	This bit enables single ended analog input, channel A 0: Differential input 1: Single ended input
4	SE B	R/W	0	This bit enables single ended analog input, channel B 0: Differential input 1: Single ended input
3	0	R/W	0	Must write 0
2	DLL PDN	R/W	0	This register powers down the internal DLL, which is used to adjust the sampling time. This register must only be enabled when operating at sampling rates below 40 MSPS. When DLL PDN bit is enabled the sampling time is directly dependent on sampling clock duty cycle (with a 50/50 duty cycle the sampling time is $T_S/2$ ). 0: Sampling time is $T_S/4$ 1: Sampling time is $T_S/2$ (only for sampling rates below 40 MSPS).
1	0	R/W	0	Must write 0
0	AZ EN	R/W	0	This bit enables the internal auto-zero circuitry. 0: Auto-zero disabled 1: Auto-zero enabled

#### Figure 8-55. Register 0x13

			•				
7	6	5	4	3	2	1	0
0	0	0	0	0	0		E-FUSE LD
R/W-0							

#### Table 8-22. Register 0x13 Field Descriptions

Bit	Field	Type	Reset	Description
7-1	0	R/W	0	Must write 0
0	E-FUSE LD	R/W	0	This register bit loads the internal bit mapping for different interfaces. After setting the interface in register 0x07, this E- FUSE LOAD bit needs to be set to 1 and reset to 0 for loading to go into effect. Register 0x07 along with the E-Fuse Load (0x13, D0) needs to be loaded first in the programming sequence since the E-Fuse load resets the SPI writes. 0: E-FUSE LOAD set 1: E-FUSE LOAD reset

ADC3660 SBASA01B – SEPTEMBER 2020 – REVISED MARCH 2022



Figure 8-56. Register 0x14/15/16									
7 6 5 4 3 2 1 0									
CUSTOM PAT [7:0]									
			CUSTOM	PAT [15:8]					
	TEST PAT B TEST PAT A CUSTOM PAT [17:16]								
R/W-0	R/W-0 R/W-0 R/W-0 R/W-0 R/W-0 R/W-0 R/W-0 R/W-0								

#### Table 8-23. Register 0x14/15/16 Field Descriptions

Bit	Field	Туре	Reset	Description
7-0	CUSTOM PAT [17:0]	R/W	0000000	<ul> <li>This register is used for two purposes:</li> <li>It sets the constant custom pattern starting from MSB</li> <li>It sets the RAMP pattern increment step size.</li> <li>00001: Ramp pattern for 18-bit ADC</li> <li>00100: Ramp pattern for 16-bit ADC</li> <li>10000: Ramp pattern for 14-bit ADC</li> </ul>
7-5	TEST PAT B	EST PAT B R/W 000 Enables test patter pattern is set prior resolution of the AI		Enables test pattern output mode for channel B (NOTE: The test pattern is set prior to the bit mapper and is based on native resolution of the ADC starting from the MSB). These work in either output format.
				000: Normal output mode (test pattern output disabled) 010: Ramp pattern: need to set proper increment using CUSTOM PAT register 011: Constant Pattern using CUSTOM PAT [17:0] in register 0x14/15/16. others: not used
4-2	TEST PAT A	R/W	000	Enables test pattern output mode for channel A (NOTE: The test pattern is set prior to the bit mapper and is based on native resolution of the ADC starting from the MSB). These work in either output format.
				000: Normal output mode (test pattern output disabled) 010: Ramp pattern: need to set proper increment using CUSTOM PAT register 011: Constant Pattern using CUSTOM PAT [17:0] in register 0x14/15/16. others: not used

#### Figure 8-57. Register 0x18

7	6	5	4	3	2	1	0		
0	0	0	DCLKIN EN	0	0	0	0		
R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0		

#### Table 8-24. Register 0x18 Field Descriptions

Bit	Field	Туре	Reset	Description					
7-5	0	R/W	0	Must write 0					
4	DCLKIN EN	R/W	1	This bit enables the DCLKIN clock input buffer for serial CMOS modes. Also DCLKIN EN (0x1F, D6) needs to be set as well.When changing the otuput interface mode (0x07) this register has to be written again. 0: DCLKIN buffer powered down. 1: DCLKIN buffer enabled.					
3-0	0	R/W	0	Must write 0					



Figure 8-58. Register 0x19									
7	6	5	4	3	2	1	0		
FCLK SRC	0	0	FCLK DIV	0	0	FCLK EN	TOG FCLK		
R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0		

#### Table 8-25. Register 0x19 Field Descriptions

Bit	Field	Туре	Reset	Description
7	FCLK SRC	R/W	0	User has to select if FCLK signal comes from ADC or from DDC block. Here real decimation is treated same as bypass mode 0: FCLK generated from ADC. FCLK SRC set to 0 for DDC bypass, real decimation mode and 1/2-w complex decimation mode. 1: FCLK generated from DDC block. In complex decimation mode only this bit needs to be set for 2-w and 1-w output interface mode but NOT for 1/2-w mode.
6-5	0	R/W	0	Must write 0
4	FCLK DIV	R/W	0	<ul> <li>This bit needs to be set to 1 for 2-w output mode in bypass mode only (non decimation).</li> <li>0: All output interface modes except 2-w bypass mode</li> <li>1: 2-w output interface mode.</li> </ul>
3-2	0	R/W	0	Must write 0
1	FCLK EN	R/W	1	This bit enables FCLK output. 0: FCLK output disabled. When changing the output interface mode (0x07) this register has to be written again. 1: FCLK output enabled.
0	TOG FCLK	R/W	0	<ul> <li>This bit adjusts the FCLK signal appropriately for 1/2-wire mode where FCLK is stretched to cover channel A and channel B.</li> <li>This bit ONLY needs to be set in 1/2-wire mode with complex decimation mode.</li> <li>0: all other modes.</li> <li>1: FCLK for 1/2-wire complex decimation mode.</li> </ul>

#### Table 8-26. Configuration of FCLK SRC and FCLK DIV Register Bits vs Serial Interface

BYPASS/DECIMATION	BYPASS/DECIMATION SERIAL INTERFACE		FCLK DIV	TOG FCLK
	2-wire	0	1	0
Decimation Bypass/ Real Decimation	1-wire	0	0	0
	1/2-wire	0	0	0
	2-wire	1	0	0
Complex Decimation	1-wire	1	0	0
	1/2-wire	0	0	1

ADC3660 SBASA01B – SEPTEMBER 2020 – REVISED MARCH 2022



Figure 8-59. Register 0x1B									
7	6 5 4 3 2 1 0								
MAPPER EN	20B EN	E	BIT MAPPER RES	3	0	0	0		
R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0		

#### Table 8-27. Register 0x1B Field Descriptions

Bit	Field	Туре	Reset	Description
7	MAPPER EN	R/W	0	This bit enables changing the resolution of the output (including output serialization factor) in bypass mode only. This bit is not needed for 20-bit resolution. 0: Output bit mapper disabled. 1: Output bit mapper enabled.
6	20B EN	R/W	0	This bit enables 20-bit output resolution which can be useful for very high decimation settings so that quantization noise doesn't impact the ADC performance. 0: 20-bit output resolution disabled. 1: 20-bit output resolution enabled.
5-3	BIT MAPPER RES	R/W	000	Sets the output resolution using the bit mapper. MAPPER EN bit (D6) needs to be enabled when operating in bypass mode 000: 18 bit 001: 16 bit 010: 14 bit all others, n/a
2-0	0	R/W	0	Must write 0

#### Table 8-28. Register Settings for Output Bit Mapper vs Operating Mode

BYPASS/DECIMATION	OUTPUT RESOLUTION	MAPPER EN (D7)	BIT MAPPER RES (D5-D3)
Decimation Bypass	Resolution Change	1	000: 18-bit
Real Decimation	Desclution Change (default 19 hit)	0	001: 16-bit
Complex Decimation	Resolution Change (default 18-bit)	0	010: 14-bit

#### Figure 8-60. Register 0x1E

7	6	5	4	3	2	1	0
0	0	CMOS D	CMOS DCLK DEL		0	0	0
R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0

#### Table 8-29. Register 0x1E Field Descriptions

Bit	Field	Туре	Reset	Description
7-6	0	R/W	0	Must write 0
5-4	CMOS DCLK DEL	R/W		These bits adjust the output timing of CMOS DCLK output. 00: no delay 01: DCLK advanced by 50 ps 10: DCLK delayed by 50 ps 11: DCLK delayed by 100 ps
3-0	0	R/W	0	Must write 0



	Figure 8-61. Register 0x1F							
7	6	5	4	3	2	1	0	
LOW DR EN	DCLKIN EN	0	DCLK OB EN	2X DCLK	0	0	0	
R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	

#### Table 8-30. Register 0x1F Field Descriptions

Bit	Field	Туре	Reset	Description
7	LOW DR EN	R/W	0	This bit impacts the output drive strength of the CMOS output buffers. This bit can be enabled at slow speeds in order to save power consumption but it will degrade the rise and fall times. 0: Low drive strength disabled. 1: Low drive strength enabled.
6	DCLKIN EN	R/W	1	<ul> <li>This bit enables the DCLKIN clock input buffer for serial CMOS modes. DCLKIN EN (0x18, D4) needs to be set as well.</li> <li>When changing the output interface mode this register has to be written again.</li> <li>0: DCLKIN buffer powered down.</li> <li>1: DCLKIN buffer enabled.</li> </ul>
5	0	R/W	0	Must write 0
4	DCLK OB EN	R/W	1	This bit enables DCLK output buffer. When changing the output interface mode (0x07) this register has to be written again. 0: DCLK output buffer powered down. 1: DCLK output buffer enabled.
3	2X DCLK	R/W	0	This bit enables SDR output clocking with serial CMOS mode. When this mode is enabled, DCLKIN required is twice as fast and data is output only on rising edge of DCLK. 0: Data output on DCLK rising and falling edge. 1: 2x DCLK mode enabled.
2-0	0	R/W	0	Must write 0

#### Figure 8-62. Register 0x20/21/22

7	6	5	4	3	2	1	0	
FCLK PAT [7:0]								
			FCLK P	AT [15:8]				
0	0	0	0	FCLK PAT [19:16]				
R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	

#### Table 8-31. Register 0x20/21/22 Field Descriptions

Bit	Field	Туре	Reset	Description					
7-0	FCLK PAT [19:0]	R/W		These bits can adjust the duty cycle of the FCLK. In decimation bypass mode the FCLK pattern gets adjusted automatically for the different output resolutions. Table 8-32 shows the proper FCLK pattern values for 1-wire and 1/2-wire in real/complex decimation.					

#### Table 8-32. FCLK Pattern for different resolution based on interface

DECIMATION	OUTPUT RESOLUTION	2-WIRE	1-WIRE	1/2-WIRE
	14-bit		0xFE000	
REAL DECIMATION	16-bit		0xFF000	Use Default
REAL DECIMATION	18-bit		0xFF800	Use Delault
	20-bit	Use Default	0xFFC00	
	14-bit		0xFFFFF	0xFFFFF
COMPLEX	16-bit		0xFFFFF	0xFFFFF
DECIMATION	18-bit	1	0xFFFFF	0xFFFFF
	20-bit		0xFFFFF	0xFFFFF

ADC3660 SBASA01B – SEPTEMBER 2020 – REVISED MARCH 2022



Figure	8-63.	Register	0x24
riguic	0-00.	Register	VALT

7	6	5	4	3	2	1	0
0	0	CH AVG EN	DDC MUX		DIG BYP	DDC EN	0
R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0

#### Table 8-33. Register 0x24 Field Descriptions

Bit	Field	Туре	Reset	Description
7-6	0	R/W	0	Must write 0
5	CH AVG EN	R/W	0	Averages the output of ADC channel A and channel B together. The DDC MUX has to be enabled and set to '11'. The decimation filter needs to be enabled and set to bypass (fullrate output) or decimation and DIG BYP set to 1. 0: Channel averaging feature disabled 1: Output of channel A and channel B are averaged: (A+B)/2.
4-3	DDC MUX	R/W	0	Configures DDC MUX in front of the decimation filter. 00: ADC channel A connected to DDC A; ADC Channel B connected to DDC B 01: ADC channel A connected to DDC A and DDC B. 10: ADC channel B connected to DDC A and DDC B. 11: Output of ADC averaging block (see CH AVG EN) given to DDC A and DDC B.
2	DIG BYP	R/W	0	This bit needs to be set to enable digital features block which includes decimation. 0: Digital feature block bypassed - lowest latency 1: Data path includes digital features
1	DDC EN	R/W	0	Enables internal decimation filter for both channels 0: DDC disabled. 1: DDC enabled.
0	0	R/W	0	Must write 0

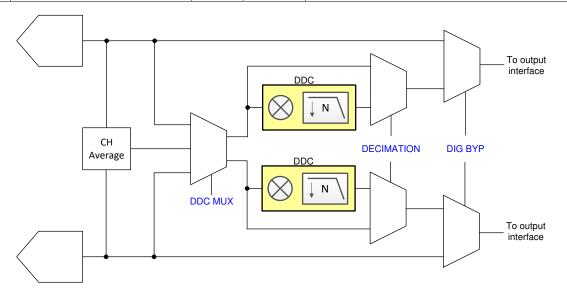


Figure 8-64. Register control for digital features



	Figure 8-65. Register 0x25								
7	6	5	4	3	2	1	0		
DDC MUX EN		DECIMATION		REAL OUT	0	0	MIX PHASE		
R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0		

#### Table 8-34. Register 0x25 Field Descriptions

Bit	Field	Туре	Reset	Description
7	DDC MUX EN	R/W	0	Enables the digital mux between ADCs and decimation filters. This bit is required for DDC mux settings in register 0x24 (D4, D3) to go into effect. 0: DDC mux disabled 1: DDC mux enabled
6-4	DECIMATION	R/W	000	Complex decimation setting. This applies to both channels. 000: Bypass mode (no decimation) 001: Decimation by 2 010: Decimation by 4 011: Decimation by 8 100: Decimation by 16 101: Decimation by 32 others: not used
3	REAL OUT	R/W	0	This bit selects real output decimation. This mode applies to both channels. In this mode, the decimation filter is a low pass filter and no complex mixing is performed to reduce power consumption. For maximum power savings the NCO in this case should be set to 0. 0: Complex decimation 1: Real decimation
2-1	0	R/W	0	Must write 0
0	MIX PHASE	R/W	0	This bit used to invert the NCO phase 0: NCO phase as is. 1: NCO phase inverted.

ADC3660 SBASA01B – SEPTEMBER 2020 – REVISED MARCH 2022



	Figure 8-66. Register 0x26								
7 6 5 4 3						2	1	0	
	MIX GAIN A MIX RES		MIX RES A	FS/4 MIX A	MIX G	AIN B	MIX RES B	FS/4 MIX B	
	R/W-0 R/W-0 R/W-0		R/W-0	R/W-0	R/W-0	R/W-0	R/W-0		

#### Table 8-35. Register 0x26 Field Descriptions

Bit	Field	Туре	Reset	Description		
7-6	MIX GAIN A	R/W	00	This bit applies a 0, 3 or 6-dB digital gain to the output of digital mixer to compensate for the mixing loss for channel A. 00: no digital gain added 01: 3-dB digital gain added 10: 6-dB digital gain added 11: not used		
5	MIX RES A	R/W				
4	FS/4 MIX A	R/W	0	Enables complex mixing with F <sub>S</sub> /4 for DDC A. 0: F <sub>S</sub> /4 mixing disabled. 1: F <sub>S</sub> /4 mixing enabled.		
3-2	MIX GAIN B	R/W	00	This bit applies a 0, 3 or 6-dB digital gain to the output of digital mixer to compensate for the mixing loss for channel B. 00: no digital gain added 01: 3-dB digital gain added 10: 6-dB digital gain added 11: not used		
1	MIX RES B	R/W	0	Toggling this bit resets the NCO phase of channel B and loads the new NCO frequency. This bit does not self reset.		
0	FS/4 MIX B	R/W	0	Enables complex mixing with $F_S/4$ for DDC B. 0: $F_S/4$ mixing disabled. 1: $F_S/4$ mixing enabled.		

#### Figure 8-67. Register 0x27

7	6	5	4	3	2	1	0
0	0	0	OP ORDER A	Q-DEL A	FS/4 MIX PH A	0	0
R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0

#### Table 8-36. Register 0x27 Field Descriptions

Bit	Field	Туре	Reset	Description
7-5	0	R/W	0	Must write 0
4	OP ORDER A	R/W	0	Swaps the I and Q output order for channel A. See Table 8-37 for recommended settings. Only used with complex decimation. Set to 0 with real decimation. 0: Output order is I[n], Q[n] 1: Output order is swapped: Q[n], I[n]
3	Q-DEL A	R/W	0	This delays the Q-sample output of channel A by one. See Table 8-37 for recommended settings. Only used with complex decimation. Set to 0 with real decimation. 0: Output order is I[n], Q[n] 1: Q-sample is delayed by 1 sample: I[n], Q[n+1], I[n+1], Q[n+2]
2	FS/4 MIX PH A	R/W	0	Inverts the mixer phase for channel A when using F <sub>S</sub> /4 mixer 0: Mixer phase is non-inverted 1: Mixer phase is inverted
1-0	0	R/W	0	Must write 0



Table 8-37. OP-ORDER	Table 8-37. OP-ORDER and Q-DELAY Register Settings for Complex Decimation								
SCMOS INTERFACE OP-ORDER Q-DELAY									
2-wire	1	0							
1-wire	0	1							
1/2-wire	1	1							

#### Figure 8-68. Register 0x2A/B/C/D

7	6	5	4	3	2	1	0			
	NCO A [7:0]									
	NCO A [15:8]									
			NCO A	[23:16]						
	NCO A [31:24]									
R/W-0	R/W-0 R/W-0 R/W-0 R/W-0 R/W-0 R/W-0 R/W-0									

#### Table 8-38. Register 0x2A/2B/2C/2D Field Descriptions

Bit	Field	Туре	Reset	Description
7-0	NCO A [31:0]	R/W		Sets the 32 bit NCO value for decimation filter channel A. The NCO value is $f_{NCO} \times 2^{32}/F_S$ In real decimation mode these registers are automatically set to 0.

#### Figure 8-69. Register 0x2E

7	6	5	4	3	2	1	0
0	0	0	OP ORDER B	Q-DEL B	FS/4 MIX PH B	0	0
R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0

#### Table 8-39. Register 0x2E Field Descriptions

Bit	Field	Туре	Reset	Description
7-5	0	R/W	0	Must write 0
4	OP ORDER B	R/W	0	Swaps the I and Q output order for channel B. See Table 8-37 for recommended settings. Only used with complex decimation. Set to 0 with real decimation. 0: Output order is I[n], Q[n] 1: Output order is swapped: Q[n], I[n]
3	Q-DEL B	R/W	0	This delays the Q-sample output of channel B by one. See Table 8-37 for recommended settings. Only used with complex decimation. Set to 0 with real decimation. 0: Output order is I[n], Q[n] 1: Q-sample is delayed by 1 sample: I[n], Q[n+1], I[n+1], Q[n+2]
2	FS/4 MIX PH B	R/W	0	Inverts the mixer phase for channel B when using F <sub>S</sub> /4 mixer 0: Mixer phase is non-inverted 1: Mixer phase is inverted
1-0	0	R/W	0	Must write 0



Figure 8-70. Register 0x31/32/33/34											
7 6 5 4 3 2 1 0											
	NCO B [7:0]										
			NCO E	8 [15:8]							
			NCO B	[23:16]							
NCO B [31:24]											
R/W-0											

	Table 8-40. Register 0x31/32/33/34 Field Descriptions				
Bit	Field	Туре	Reset	Description	
7-0	NCO B [31:0]	R/W	0	Sets the 32 bit NCO value for decimation filter channel B. The NCO value is $f_{NCO} \times 2^{32}/F_S$ In real decimation mode these registers are automatically set to 0.	

#### Figure 8-71. Register 0x39..0x60

7	6	5	4	3	2	1	0	
	OUTPUT BIT MAPPER CHA							
R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	

#### Table 8-41. Register 0x39..0x60 Field Descriptions

Bit	Field	Туре	Reset	Description	
7-0	OUTPUT BIT MAPPER CHA	R/W		These registers are used to reorder the output data bus. See the Section 8.3.5.4 on how to program it.	

#### Figure 8-72. Register 0x61..0x88

7	6	5	4	3	2	1	0	
OUTPUT BIT MAPPER CHB								
R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	

#### Table 8-42. Register 0x61..0x88 Field Descriptions

Bit	Field	Туре	Reset	Description
7-0	OUTPUT BIT MAPPER CHB	R/W	0	These registers are used to reorder the output data bus. See the Section 8.3.5.4 on how to program it.



#### Figure 8-73. Register 0x8F 6 5 4 2 0 7 3 1 0 0 0 0 0 0 FORMAT A 0 R/W-0 R/W-0 R/W-0 R/W-0 R/W-0 R/W-0 R/W-0 R/W-0

#### Table 8-43. Register 0x8F Field Descriptions

Bit	Field	Туре	Reset	Description
7-2	0	R/W	0	Must write 0
1	FORMAT A	R/W		This bit sets the output data format for channel A. Digital bypass register bit (0x24, D2) needs to be enabled as well. 0: 2s complement 1: Offset binary
0	0	R/W	0	Must write 0

#### Figure 8-74. Register 0x92

7	6	5	4	3	2	1	0
0	0	0	0	0	0	FORMAT B	0
R/W-0	R/W-0						

#### Table 8-44. Register 0x92 Field Descriptions

Bit	Field	Туре	Reset	Description
7-2	0	R/W	0	Must write 0
1	FORMAT B	R/W		This bit sets the output data format for channel B. Digital bypass register bit (0x24, D2) needs to be enabled as well. 0: 2s complement 1: Offset binary
0	0	R/W	0	Must write 0



#### **9** Application and Implementation

#### Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

#### 9.1 Typical Application

A sonar receiver is a typical frequency domain application for the ADC3660 and its front end circuitry is very similar to several other systems such as software defined radio (SDR), spectrum analyzer, radar or communications. Some applications require frequency coverage including DC or near DC (such as, sonar), so it is included in this example.

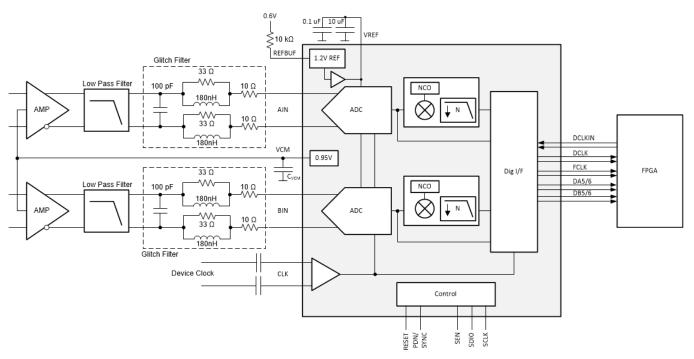


Figure 9-1. Typical configuration for a spectrum analyzer with DC support

#### 9.1.1 Design Requirements

Frequency domain applications cover a wide range of frequencies from low input frequencies at or near DC in the 1st Nyquist zone to undersampling in higher Nyquist zones. If very low input frequency is supported then the input has to be DC coupled and the ADC driven by a fully differential amplifier (FDA). If low frequency support is not needed then AC coupling and use of a balun may be more suitable.

The internal reference is used since DC precision is not needed. However the ADC AC performance is highly dependent on the quality of the external clock source. If in-band interferers can be present then the ADC SFDR performance will be a key care about as well. A higher ADC sampling rate is desirable in order to relax the external anti-aliasing filter – an internal decimation filter can be used to reduce the digital output rate afterwards.

FEATURE	DESCRIPTION				
Signal Bandwidth	DC to 2 MHz				
Input Driver Single ended to differential signal conversion and DC coupling					

#### Table 9-1. Design key care-abouts

Table 9-1. Design key care-abouts (continued)			
FEATURE	DESCRIPTION		
Clock Source	External clock with low jitter		

When designing the amplifier/filter driving circuit, the ADC input full-scale voltage needs to be taken into consideration. For example, the ADC3660 input full-scale is 3.2Vpp. When factoring in ~ 1 dB for insertion loss of the filter, then the amplifier needs to deliver close to 3.6Vpp. The amplifier distortion performance will degrade with a larger output swing and considering the ADC common mode input voltage the amplifier may not be able to deliver the full swing. The ADC3660 provides an output common mode voltage of 0.95V and the THS4551 for example can only swing all the way to its negative supply. A unipolar 3.3 V amplifier power supply will thus limit the maximum voltage swing to ~ 3.8Vpp. If a larger output swing is required (ie larger filter insertion loss) then a negative supply for the amplifier is needed in order to eliminate that limitation. Additionally input voltage protection diodes may be needed to protect the ADC from over-voltage events.

#### Table 9-2. Output voltage swing of THS4541 vs power supply

DEVICE	MIN OUTPUT VOLTAGE	MAX SWING WITH 3.3 V/ 0 V SUPPLY		
THS4551	VS-	3.8 Vpp		

#### 9.1.2 Detailed Design Procedure

#### 9.1.2.1 Input Signal Path

Depending on desired input signal frequency range the THS4551 and THS4541 provide very good low power options to drive the ADC inputs. Table 9-3 provides a comparison between the THS4551 and THS4541 and the power consumption vs usable frequency trade off.

······································							
DEVICE	CURRENT (IQ) PER CHANNEL	USABLE FREQUENCY RANGE					
THS4561	0.8 mA	< 3 MHz					
THS4551	1.4 mA	< 10 MHz					
THS4541	10 mA	< 70 MHz					

#### Table 9-3. Fully Differential Amplifier Options

The low pass filter design (topology, filter order) is driven by the application itself. However, when designing the low pass filter, the optimum load impedance for the amplifier should be taken into consideration as well. Between the low pass filter and the ADC input the sampling glitch filter needs to added as well as shown in Section 8.3.1.2.1. In this example the DC - 30 MHz glitch filter is selected.

#### 9.1.2.2 Sampling Clock

Applications operating with low input frequencies (such as DC to 2 MHz) typically are less sensitive to performance degradation due to clock jitter. The internal ADC aperture jitter improves with faster rise and fall times (i.e. square wave vs sine wave). Table 9-4 provides an overview of the estimated SNR performance of the ADC3660 based on different amounts of jitter of the external clock source. The SNR is estimated based on ADC3660 thermal noise of 82 dBFS and input signal at -1dBFS in decimation bypass mode.

#### Table 9-4. ADC SNR performance across vs input frequency for different amounts of external clock jitter

INPUT FREQUENCY	T <sub>J,EXT</sub> = 100 fs	T <sub>J,EXT</sub> = 250 fs	T <sub>J,EXT</sub> = 500 fs	T <sub>J,EXT</sub> = 1 ps
1 MHz	82.0	82.0	82.0	82.0
2 MHz	82.0	82.0	82.0	81.9
5 MHz	82.0	81.9	81.8	81.5

Termination of the clock input should be considered for long clock traces.

#### 9.1.2.3 Voltage Reference

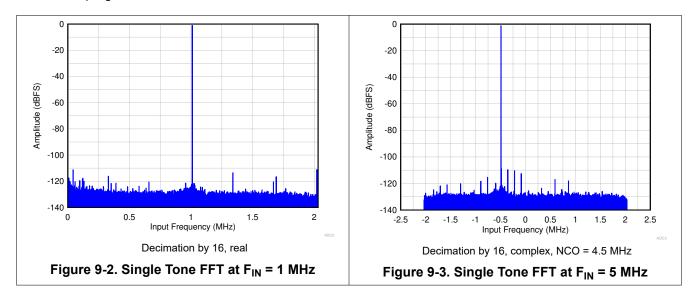
The ADC3660 is configured to internal reference operation by applying 0.6 V to the REFBUF pin.



#### 9.1.3 Application Curves

The following FFT plots show the performance of THS4541 driving the ADC3660 operated at 65 MSPS with a full-scale input at -1 dBFS. The first FFT spectrum below shows the performance with a single tone input at  $F_{IN}$  = 1 MHz and decimation by 16 (real).

The second FFT spectrum shows the a single tone input at  $F_{IN}$  = 5 MHz and complex decimation by 16 where the NCO is programmed to 4.5 MHz.





#### 9.2 Initialization Set Up

After power-up, the internal registers must be initialized to their default values through a hardware reset by applying a high pulse on the RESET pin, as shown in Figure 9-4.

- 1. Apply AVDD and IOVDD (no specific sequence required). After AVDD is applied the internal bandgap reference will power up and settle out in ~ 2ms.
- 2. Configure REFBUF pin (pull high or low even if configured via SPI later on) and apply the sampling clock.
- Apply hardware reset. After hardware reset is released, the default registers are loaded from internal fuses and the internal power up capacitor calibration is initiated. The calibration takes approximately 200000 clock cycles.
- 4. Begin programming using SPI interface.

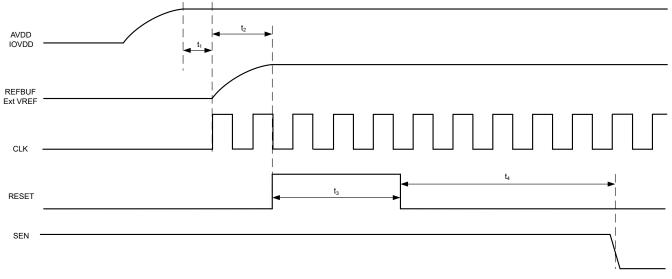


Figure 9-4. Initialization of Serial Registers after Power up

#### Table 9-5. Power-up Timing

		MIN	ТҮР	MAX	UNIT
t <sub>1</sub>	Power-on delay: delay from power up to logic level of REFBUF pin	2			ms
t <sub>2</sub>	Delay from REFBUF pin logic level to RESET rising edge	100			ns
t <sub>3</sub>	RESET pulse width	1			us
t <sub>4</sub>	Delay from RESET disable to SEN active	~ 200000			clock cycles

#### 9.2.1 Register Initialization During Operation

If required, the serial interface registers can be cleared and reset to default settings during operation either:

- through a hardware reset or
- by applying a software reset. When using the serial interface, set the RESET bit (D0 in register address 0x00) high. This setting initializes the internal registers to the default values and then self-resets the RESET bit low. In this case, the RESET pin is kept low.

After hardware or software reset the wait time is also ~ 200000 clock cycles before the SPI registers can be programmed.



#### **10 Power Supply Recommendations**

The ADC3660 requires two different power-supplies. The AVDD rail provides power for the internal analog circuits and the ADC itself while the IOVDD rail powers the digital interface and the internal digital circuits like decimation filter or output interface mapper. Power sequencing is not required.

The AVDD power supply must be low noise in order to achieve data sheet performance. In applications operating near DC, the 1/f noise contribution of the power supply needs to be considered as well. The ADC is designed for very good PSRR which aides with the power supply filter design.

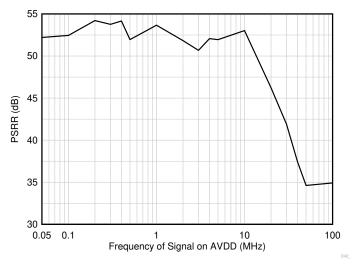


Figure 10-1. Power supply rejection ratio (PSRR) vs frequency

There are two recommended power-supply architectures:

- 1. Step down using high-efficiency switching converters, followed by a second stage of regulation using a low noise LDO to provide switching noise reduction and improved voltage accuracy.
- 2. Directly step down the final ADC supply voltage using high-efficiency switching converters. This approach provides the best efficiency, but care must be taken to ensure switching noise is minimized to prevent degraded ADC performance.

TI WEBENCH Power Designer can be used to select and design the individual power-supply elements needed: see the WEBENCH Power Designer

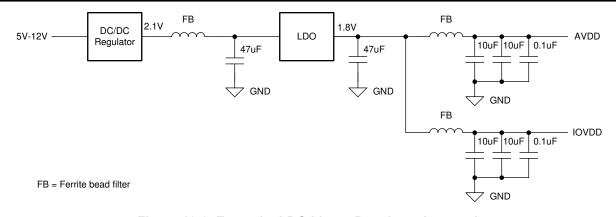
Recommended switching regulators for the first stage include the TPS62821, and similar devices.

Recommended low dropout (LDO) linear regulators include the TPS7A4701, TPS7A90, LP5901, and similar devices.

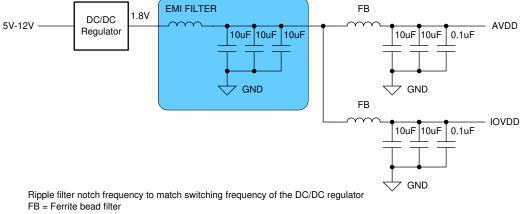
For the switch regulator only approach, the ripple filter must be designed with a notch frequency that aligns with the switching ripple frequency of the DC/DC converter. Note the switching frequency reported from WEBENCH and design the EMI filter and capacitor combination to have the notch frequency centered as needed. Figure 10-2 and Figure 10-3 illustrate the two approaches.

AVDD and IOVDD supply voltages should not be shared in order to prevent digital switching noise from coupling into the analog signal chain.









#### Figure 10-3. Example Switcher-Only Approach



#### 11 Layout

#### **11.1 Layout Guidelines**

There are several critical signals which require specific care during board design:

- 1. Analog input and clock signals
  - Traces should be as short as possible and vias should be avoided where possible to minimize impedance discontinuities.
  - Traces should be routed using loosely coupled  $100-\Omega$  differential traces.
  - Differential trace lengths should be matched as close as possible to minimize phase imbalance and HD2 degradation.
- 2. Digital output interface
  - A 20 ohm series isolation resistor should be used on each CMOS output and placed close the digital output. This isolation resistor limits the output current into the capacitive load and thus minimizes the switching noise inside the ADC. When driving longer distances a buffer should be used. The resistor value should be optimized for the desired output data rate.
- 3. Voltage reference
  - The bypass capacitor should be placed as close to the device pins as possible and connected between VREF and REFGND – on top layer avoiding vias.
  - Depending on configuration an additional bypass capacitor between REFBUF and REFGND may be recommended and should also be placed as close to pins as possible on top layer.
- 4. Power and ground connections
  - Provide low resistance connection paths to all power and ground pins.
  - Use power and ground planes instead of traces.
  - Avoid narrow, isolated paths which increase the connection resistance.
  - Use a signal/ground/power circuit board stackup to maximize coupling between the ground and power plane.

#### 11.2 Layout Example

The following screen shot shows the top layer of the ADC364x/ADC3660 EVM.

- Signal and clock inputs are routed as differential signals on the top layer avoiding vias.
- Serial CMOS output interface lanes with isolation resistor and digital buffer.
- Bypass caps are close to the VREF pin on the top layer avoiding vias.

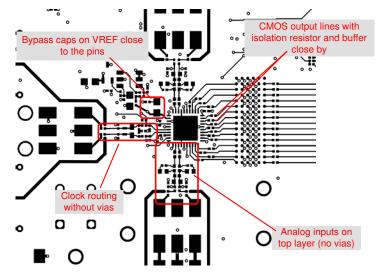


Figure 11-1. Layout example: top layer of ADC3660 EVM



#### **12 Device and Documentation Support**

#### 12.1 Support Resources

TI E2E<sup>™</sup> support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

#### 12.2 Trademarks

TI E2E<sup>™</sup> is a trademark of Texas Instruments.

All trademarks are the property of their respective owners.

#### 12.3 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

#### 12.4 Glossary

TI Glossary This glossary lists and explains terms, acronyms, and definitions.

#### 13 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.



#### PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
ADC3660IRSBR	ACTIVE	WQFN	RSB	40	3000	RoHS & Green	NIPDAU	Level-3-260C-168 HR	-40 to 105	AZ3660	Samples
ADC3660IRSBT	ACTIVE	WQFN	RSB	40	250	RoHS & Green	NIPDAU	Level-3-260C-168 HR	-40 to 105	AZ3660	Samples

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

**RoHS Exempt:** TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <= 1000ppm threshold. Antimony trioxide based flame retardants must also meet the <= 1000ppm threshold requirement.

<sup>(3)</sup> MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>(4)</sup> There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

<sup>(5)</sup> Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

<sup>(6)</sup> Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

**Important Information and Disclaimer:**The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.



www.ti.com

## PACKAGE OPTION ADDENDUM

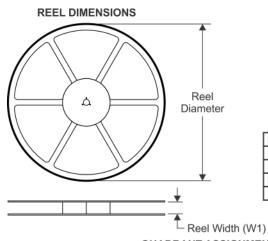
28-Feb-2022

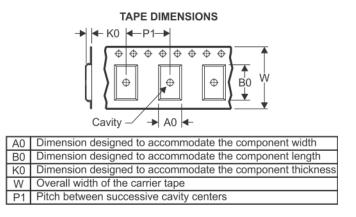
## PACKAGE MATERIALS INFORMATION

Texas Instruments

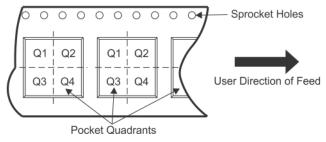
www.ti.com

#### TAPE AND REEL INFORMATION





#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



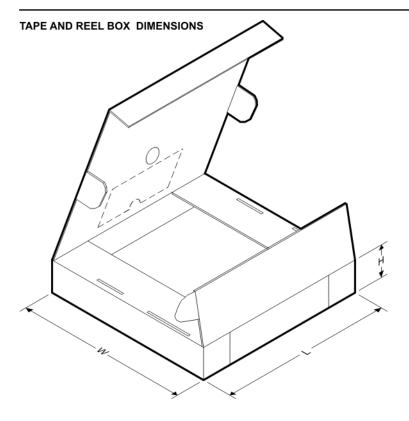
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
ADC3660IRSBR	WQFN	RSB	40	3000	330.0	12.4	5.3	5.3	1.5	8.0	12.0	Q2



www.ti.com

## PACKAGE MATERIALS INFORMATION

28-Feb-2022



\*All dimensions are nominal

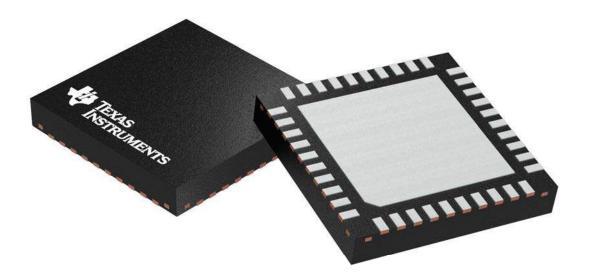
Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
ADC3660IRSBR	WQFN	RSB	40	3000	350.0	350.0	43.0

## **RSB 40**

5 x 5 mm, 0.4 mm pitch

## **GENERIC PACKAGE VIEW**

# WQFN - 0.8 mm max height PLASTIC QUAD FLATPACK - NO LEAD



Images above are just a representation of the package family, actual package may vary. Refer to the product data sheet for package details.



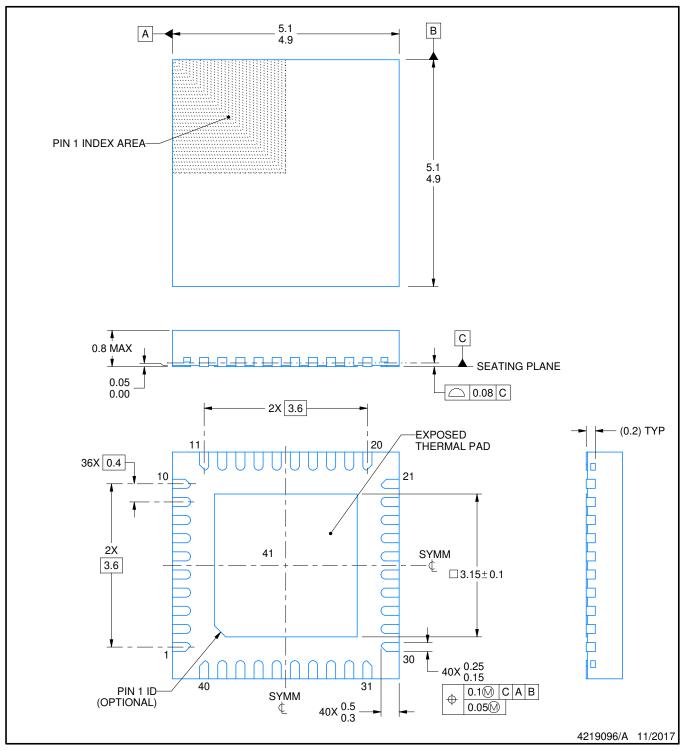
## **RSB0040E**



## **PACKAGE OUTLINE**

## WQFN - 0.8 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



#### NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice.
- 3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.

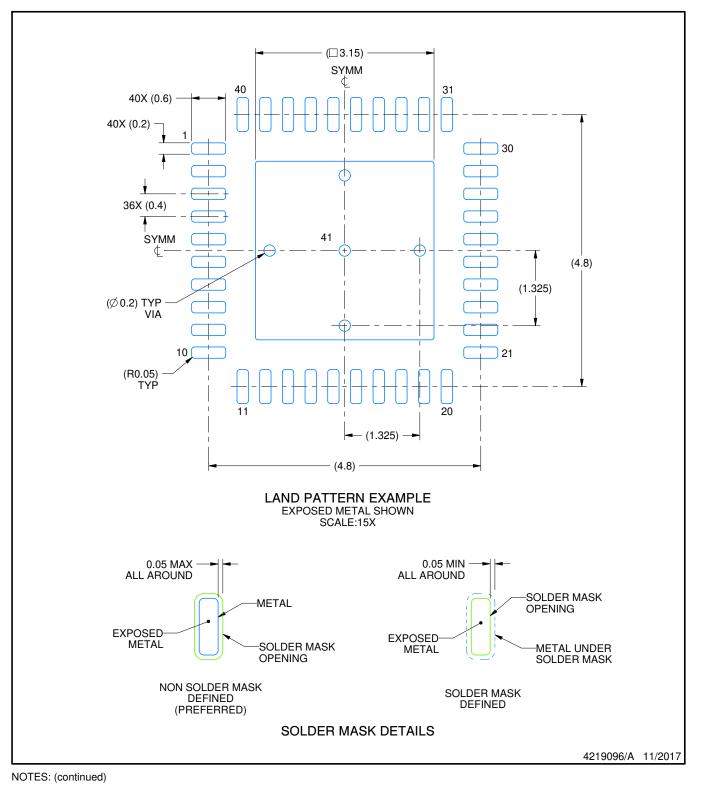


## **RSB0040E**

## **EXAMPLE BOARD LAYOUT**

#### WQFN - 0.8 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



 This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).

5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.

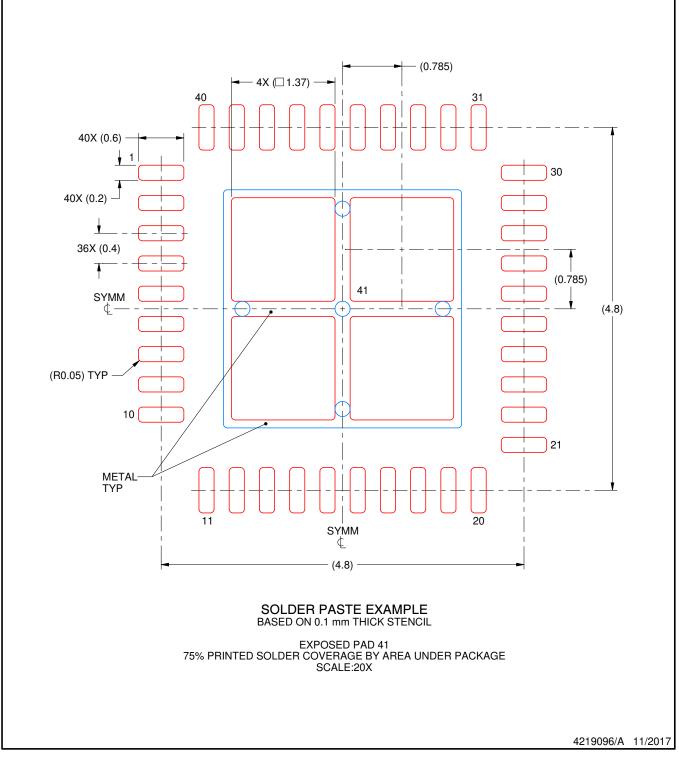


## **RSB0040E**

## **EXAMPLE STENCIL DESIGN**

## WQFN - 0.8 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.



#### IMPORTANT NOTICE AND DISCLAIMER

TI PROVIDES TECHNICAL AND RELIABILITY DATA (INCLUDING DATA SHEETS), DESIGN RESOURCES (INCLUDING REFERENCE DESIGNS), APPLICATION OR OTHER DESIGN ADVICE, WEB TOOLS, SAFETY INFORMATION, AND OTHER RESOURCES "AS IS" AND WITH ALL FAULTS, AND DISCLAIMS ALL WARRANTIES, EXPRESS AND IMPLIED, INCLUDING WITHOUT LIMITATION ANY IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE OR NON-INFRINGEMENT OF THIRD PARTY INTELLECTUAL PROPERTY RIGHTS.

These resources are intended for skilled developers designing with TI products. You are solely responsible for (1) selecting the appropriate TI products for your application, (2) designing, validating and testing your application, and (3) ensuring your application meets applicable standards, and any other safety, security, regulatory or other requirements.

These resources are subject to change without notice. TI grants you permission to use these resources only for development of an application that uses the TI products described in the resource. Other reproduction and display of these resources is prohibited. No license is granted to any other TI intellectual property right or to any third party intellectual property right. TI disclaims responsibility for, and you will fully indemnify TI and its representatives against, any claims, damages, costs, losses, and liabilities arising out of your use of these resources.

TI's products are provided subject to TI's Terms of Sale or other applicable terms available either on ti.com or provided in conjunction with such TI products. TI's provision of these resources does not expand or otherwise alter TI's applicable warranties or warranty disclaimers for TI products.

TI objects to and rejects any additional or different terms you may have proposed.

Mailing Address: Texas Instruments, Post Office Box 655303, Dallas, Texas 75265 Copyright © 2022, Texas Instruments Incorporated